

Test Report

(EN 50155 & EN 50121-3-2)

Report No.: CEBDBO-WTW-P23040108-1

Test Model: EIC-2000

Series Model: EIC-2000 Series, EIC-2XXXXXXXXXXXXXXXXX ("X" can be 0-9, A-Z, or blank for marketing purpose)

Received Date: 2023/4/7

Test Date: 2023/4/11 ~ 2023/4/28

Issued Date: 2023/5/12

Applicant: Vecow Co., Ltd.

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Issued By: Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch
Lin Kou Laboratories

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Table of Contents

Release Control Record	4
1 Certificate of Conformity	5
2 Summary of Test Results	6
2.1 Performance Criteria	9
2.2 Measurement Uncertainty	9
2.3 Modification Record.....	9
3 General Information	10
3.1 Description of EUT	10
3.2 Features of EUT	10
3.3 Operating Modes of EUT and Determination of Worst Case Operating Mode	11
3.4 Test Program Used and Operation Descriptions.....	11
3.5 Primary Clock Frequencies of Internal Source	11
4 Configuration and Connections with EUT	12
4.1 Connection Diagram of EUT and Peripheral Devices.....	12
4.2 Configuration of Peripheral Devices and Cable Connections	14
5 Conducted Disturbance at Auxiliary a.c. or d.c. Power Ports	16
5.1 Limits	16
5.2 Test Instruments	16
5.3 Test Arrangement	17
5.4 Test Results	18
6 Radiated Disturbance up to 1 GHz	20
6.1 Limits	20
6.2 Test Instruments	20
6.3 Test Arrangement	21
6.4 Test Results	22
7 Radiated Disturbance above 1 GHz	24
7.1 Limits	24
7.2 Test Instruments	25
7.3 Test Arrangement	26
7.4 Test Results	27
8 Harmonics Current Measurement	29
8.1 Limits	29
8.2 Classification of Equipment.....	29
8.3 Test Instruments	29
8.4 Test Arrangement	30
8.5 Test Results	30
9 Voltage Fluctuations and Flicker Measurement	31
9.1 Limits	31
9.2 Test Instruments	31
9.3 Test Arrangement	31
9.4 Test Results	32
10 Electrostatic Discharge Immunity Test (ESD)	33
10.1 Test Specification.....	33
10.2 Test Instruments	33
10.3 Test Arrangement	34
10.4 Test Results	35

11	Radio-frequency Electromagnetic Field Immunity Test (RS)	39
11.1	Test Specification.....	39
11.2	Test Instruments	39
11.3	Test Arrangement	41
11.4	Test Results	41
12	Electrical Fast Transient/Burst Immunity Test (EFT)	42
12.1	Test Specification.....	42
12.2	Test Instruments	42
12.3	Test Arrangement	43
12.4	Test Results	44
13	Surge Immunity Test	45
13.1	Test Specification.....	45
13.2	Test Instruments	45
13.3	Test Arrangement	46
13.4	Test Results	46
14	Immunity to Conducted Disturbances Induced by RF Fields (CS)	47
14.1	Test Specification.....	47
14.2	Test Instruments	47
14.3	Test Arrangement	49
14.4	Test Results	50
15	Pictures of Test Arrangements	51
15.1	Conducted Disturbance at Auxiliary a.c. or d.c. power ports	51
15.2	Radiated Disturbance up to 1 GHz	52
15.3	Radiated Disturbance above 1 GHz.....	53
15.4	Harmonics Current, Voltage Fluctuations and Flicker Measurement.....	54
15.5	Electrostatic Discharge Immunity Test (ESD)	54
15.6	Radio-frequency Electromagnetic Field Immunity Test (RS)	55
15.7	Fast Transients (EFT).....	56
15.8	Surge	57
15.9	Radio-frequency common mode (CS).....	58
Appendix – Information of the Testing Laboratories		59

Release Control Record

Issue No.	Description	Date Issued
CEBDBO-WTW-P23040108-1	Original release.	2023/5/12

1 Certificate of Conformity

Product: Edge AI Computing System
Brand: Vecow
Test Model: EIC-2000
Series Model: EIC-2000 Series, EIC-2XXXXXXXXXXXXXXXXX ("X" can be 0-9, A-Z, or blank for marketing purpose)
Sample Status: Engineering sample
Applicant: Vecow Co., Ltd.
Test Date: 2023/4/11 ~ 2023/4/28
Standards: **EN 50155:2017, Clause 13.4.8**
EN 61000-3-2:2014
EN IEC 61000-3-2:2019 +A1:2021
EN 61000-3-3:2013 +A2:2021
EN 50121-1:2017
EN 50121-3-2:2016
EN 61000-4-2:2009
EN 61000-4-3:2006 +A1:2008 +A2:2010
EN IEC 61000-4-3:2020
EN 61000-4-4:2012
EN 61000-4-5:2014 +A1:2017
EN 61000-4-6:2014 +AC:2015

The above equipment has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

Prepared by : Albee Chu , **Date:** 2023/5/12
Albee Chu / Specialist

Approved by : Jim Hsiang , **Date:** 2023/5/12
Jim Hsiang / Associate Technical Manager

2 Summary of Test Results

EN 50121-3-2:2016, Emission requirements, EN 50155:2017, Clause 13.4.8			
Port	Test Item / specifications	Result/Remarks	Verdict
Auxiliary a.c. or d.c. power ports - Auxiliary supply sinusoidal a.c. or d.c.	Conducted disturbance 150 kHz- 500 kHz: 99 dB μ V quasi-peak 500 kHz- 30 MHz: 93 dB μ V quasi-peak	Minimum passing margin is -48.08 dB at 0.63519 MHz	Pass
Auxiliary a.c. or d.c. power ports – AC power outlet port for public use	Conducted disturbance 50 Hz- 2 kHz: THD <8% (THD: total harmonic distortion)	Test not applicable because the port does not exist.	N/A
Battery referenced ports - Battery power supply	Conducted disturbance 150 kHz- 500 kHz: 99 dB μ V quasi-peak 500 kHz- 30 MHz: 93 dB μ V quasi-peak	Test not applicable because the port does not exist.	N/A
Enclosure	Radiated disturbance 30 MHz- 230 MHz: 40 dB μ V/m quasi-peak 230 MHz -1 GHz: 47 dB μ V/m quasi-peak	Minimum passing margin is -0.27 dB at 891.01 MHz	Pass
Enclosure	Radiated disturbance 1 GHz- 3 GHz: 76 dB μ V/m peak 56 dB μ V/m average 3 GHz - 6 GHz: 80 dB μ V/m peak 60 dB μ V/m average	Minimum passing margin is -7.16 dB at 1188.04 MHz	Pass

Emission requirements			
Standard	Test Item / specifications	Result/Remarks	Verdict
EN 61000-3-2:2014 EN IEC 61000-3-2:2019+A1:2021	Harmonic current emissions	The power consumption of EUT is less than 75W and no limits apply.	Pass
EN 61000-3-3:2013+A2:2021	Voltage fluctuations and flicker	$P_{st} \leq 1.0$ $d_{max} \leq 4\%$ $P_{lt} \leq 0.65$ $d_c \leq 3.3\%$ $T_{max} \leq 500ms$	Pass

EN 50121-3-2:2016, Immunity requirements,
EN 50155:2017, Clause 13.4.8

Table Clause	Basic standard	Port	Test Item / specifications	Result/Remarks	Verdict
3.1	EN 61000-4-6:2014 +AC:2015	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms)	Radio-frequency common mode (CS) 80% AM (1kHz) 0.15-80 MHz, 10V Performance Criterion A	Performance Criterion A	Pass
3.2	EN 61000-4-4:2012	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms)	Fast Transients (EFT) 5/50 (tr/tw) ns, 5kHz ± 2 kV Performance Criterion A	Performance Criterion A	Pass
3.3	EN 61000-4-5:2014 +A1:2017	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms)	Surges 1.2/50 (8/20) (T _i /T _d) μ s Line to ground: ± 2 kV 42 Ω , 0.5 μ F Line to line: ± 1 kV 42 Ω , 0.5 μ F Performance Criterion B	Performance Criterion A	Pass
4.1	EN 61000-4-6:2014 +AC:2015	Signal & communication, process measurement & control ports	Radio-frequency common mode (CS) 80% AM (1kHz) 0.15-80 MHz, 10V Performance Criterion A	Performance Criterion A	Pass
4.2	EN 61000-4-4:2012	Signal & communication, process measurement & control ports	Fast Transients (EFT) 5/50 (tr/tw) ns, 5kHz ± 2 kV, Capacitive clamp Performance Criterion A	Performance Criterion A	Pass
5.1	EN 61000-4-3:2006 +A1:2008 +A2:2010/ EN IEC 61000-4-3:2020	Enclosure ports	Radio-frequency electromagnetic field amplitude modulated (RS) ¹ , 80% AM (1kHz) 80-800 MHz, 20V/m Performance Criterion A	Performance Criterion A	Pass
5.2	EN 61000-4-3:2006 +A1:2008 +A2:2010/ EN IEC 61000-4-3:2020	Enclosure ports	Radio-frequency electromagnetic field from digital mobile telephones (RS) ² , 80% AM (1kHz) 800-1000 MHz, 20V/m 1400-2000 MHz, 10V/m 2000-2700 MHz, 5V/m 5100-6000 MHz, 3V/m Performance Criterion A	Performance Criterion A	Pass

EN 50121-3-2:2016, Immunity requirements,
EN 50155:2017, Clause 13.4.8

Table Clause	Basic standard	Port	Test Item / specifications	Result/Remarks	Verdict
5.3	EN 61000-4-2:2009	Enclosure ports	Electrostatic Discharges (ESD) ±6kV Contact discharge ±8kV Air discharge Performance Criterion B	Performance Criterion B	Pass

Note 1: This limit applies to equipment mounted in the passenger compartments, drivers cab or external to the rolling stock (roof, underframe). For equipment mounted in all other areas a severity level of 10 V/m may be used.

Note 2: For large apparatus (e.g. traction drives, auxiliary converters) it is often not practical to perform the immunity test to radiated electromagnetic fields on the complete unit. In such cases the manufacturer should test susceptible sub-systems (e.g. control electronics). The test report should justify the selection or not of sub-systems and any assumptions made (e.g. reduction of field due to case shielding).

Note:

1. There is no deviation to the applied test methods and requirements covered by the scope of this report.
2. The above EN basic standards are applied with latest version if customer has no special requirement.
3. Determining compliance based on the results of the compliance measurement, not taking into account measurement instrumentation uncertainty.
4. N/A: Not Applicable

2.1 Performance Criteria

General Performance Criteria

The general performance criteria apply for those ports for which no specific performance criteria are defined (e.g. auxiliary ports) in the report.

Performance criterion A: The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended..

Performance criterion B: The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed. No change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.

Performance criterion C: Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.

2.2 Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

Measurement	Expanded Uncertainty (k=2) (\pm)	Maximum allowable uncertainty (\pm)
Conducted disturbance at mains port using AMN, 150kHz ~ 30MHz	2.94 dB	3.4 dB (U_{cispr})
Radiated disturbance, 30MHz ~ 1GHz	3m : 5.72 dB 10m : 4.38 dB	6.3 dB (U_{cispr})
Radiated disturbance, 1GHz ~ 6GHz	4.94 dB	5.2 dB (U_{cispr})

The other instruments specified are routine verified to remain within the calibrated levels, no measurement uncertainty is required to be calculated.

2.3 Modification Record

There were no modifications required for compliance.

3 General Information

3.1 Description of EUT

Product	Edge AI Computing System
Brand	Vecow
Test Model	EIC-2000
Series Model	EIC-2000 Series, EIC-2XXXXXXXXXXXXXXXXX ("X" can be 0-9, A-Z, or blank for marketing purpose)
Sample Status	Engineering sample
Operating Software	Ubuntu 20.04 LTS
Power Supply Rating	DC from Adapter
Accessory Device	Adapter
Data Cable Supplied	N/A

Note:

The EUT uses following accessory.

Brand	Model	Specification
LITEON	PA-1121-24	AC Input : 100-240V, 2.0A, 50-60Hz DC Output : 24V, 50A, 120W DC Output Cable: 1.5m with one ferrite core

3.2 Features of EUT

- The tests reported herein were performed according to the method specified by Vecow Co., Ltd., for detailed feature description, please refer to the manufacturer's specifications or user's manual.
- The EUT configured with the following key components:

Component	Specification
CPU	NXP i.MX 8M Plus Quad Core Arm Cortex-A53 processor 1.8GHz
RAM	On-board 4GB LPDDR4 SDRAM
Storage	On-board 32GB eMMC

3.3 Operating Modes of EUT and Determination of Worst Case Operating Mode

1. The EUT has been pre-tested under following test modes.

Test Condition	
Mode	Radiated Emissions up to 1 GHz
1	Full system + Input Power(230 Vac, 50 Hz)
2	Full system + Input Power(120 Vac, 60 Hz)
Note: The worst case is that mode 2 is shown in bold.	

2. Test modes are presented in the report as below.

Test Condition	
Mode	Conducted Emissions from Power Ports
A	Full system + Input Power(230 Vac, 50 Hz)
Mode	Radiated Emissions up to 1 GHz
A	Full system + Input Power(120 Vac, 60 Hz)
Mode	Radiated Emissions above 1 GHz
A	Full system + Input Power(120 Vac, 60 Hz)

3.4 Test Program Used and Operation Descriptions

Emission tests (Harmonics & Flicker excluded):

- Turned on the power of all equipment.
- EUT ran a test program to enable all functions.
- EUT read and wrote messages to/ from Micro SD card.
- EUT sent "H" messages to monitor. Then the displayed messages on their screens simultaneously.
- EUT sent and received messages to/ from Laptop (kept in a remote area) via STP LAN cables (10m each).
- EUT sent "1kHz audio" signal to earphone
- Steps c-f were repeated.

Harmonics & Flicker & Immunity tests:

- Turned on the power of all equipment.
- EUT ran a test program to enable all functions.
- EUT read and wrote messages to/ from Micro SD card.
- EUT sent "color bars with moving element" messages to monitor. Then the monitor displayed messages on their screens simultaneously.
- EUT sent and received messages to/ from Laptop (kept in a remote area) via STP LAN cables (10m each).
- EUT sent audio signal to earphone.
- Steps c-f were repeated.

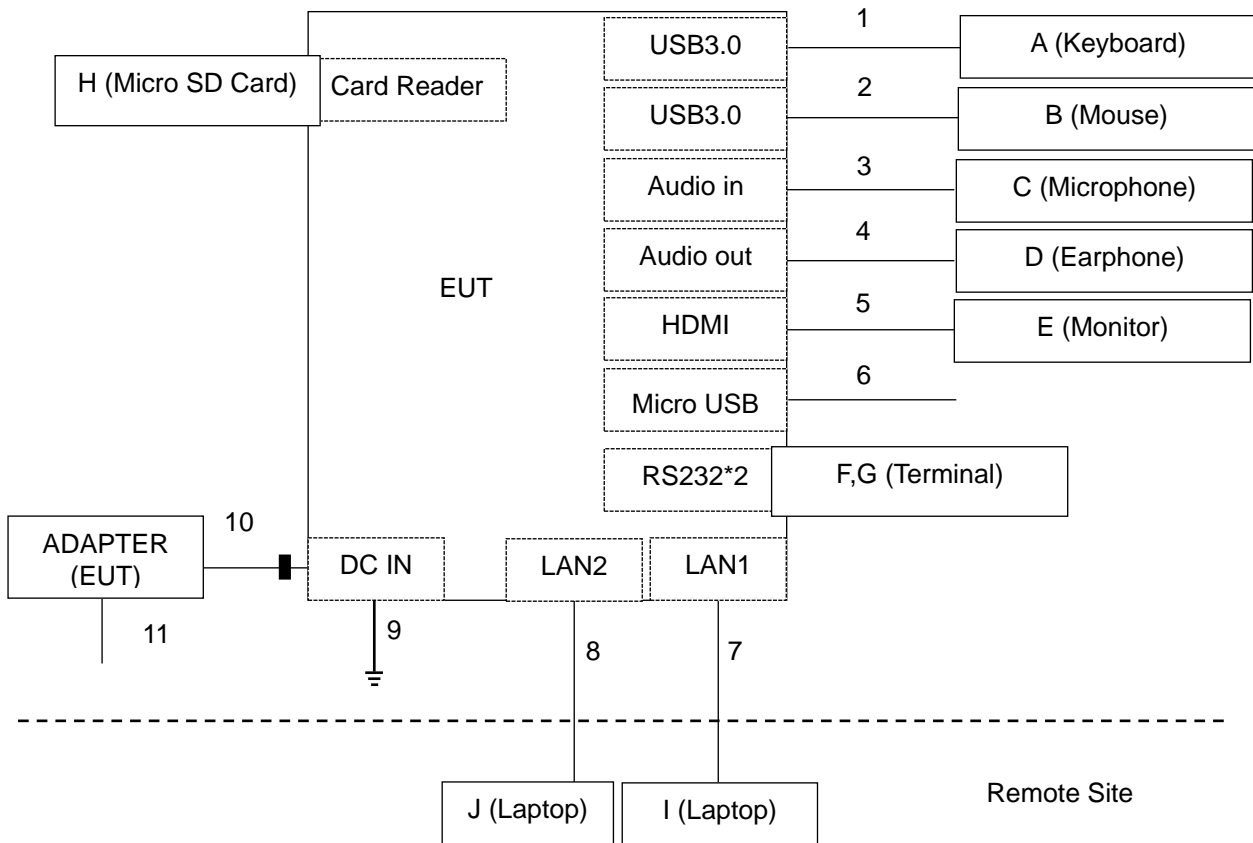
3.5 Primary Clock Frequencies of Internal Source

The highest frequency generated or used within the EUT or on which the EUT operates or tunes is 1.8GHz, provided by Vecow Co., Ltd., for detailed internal source, please refer to the manufacturer's specifications.

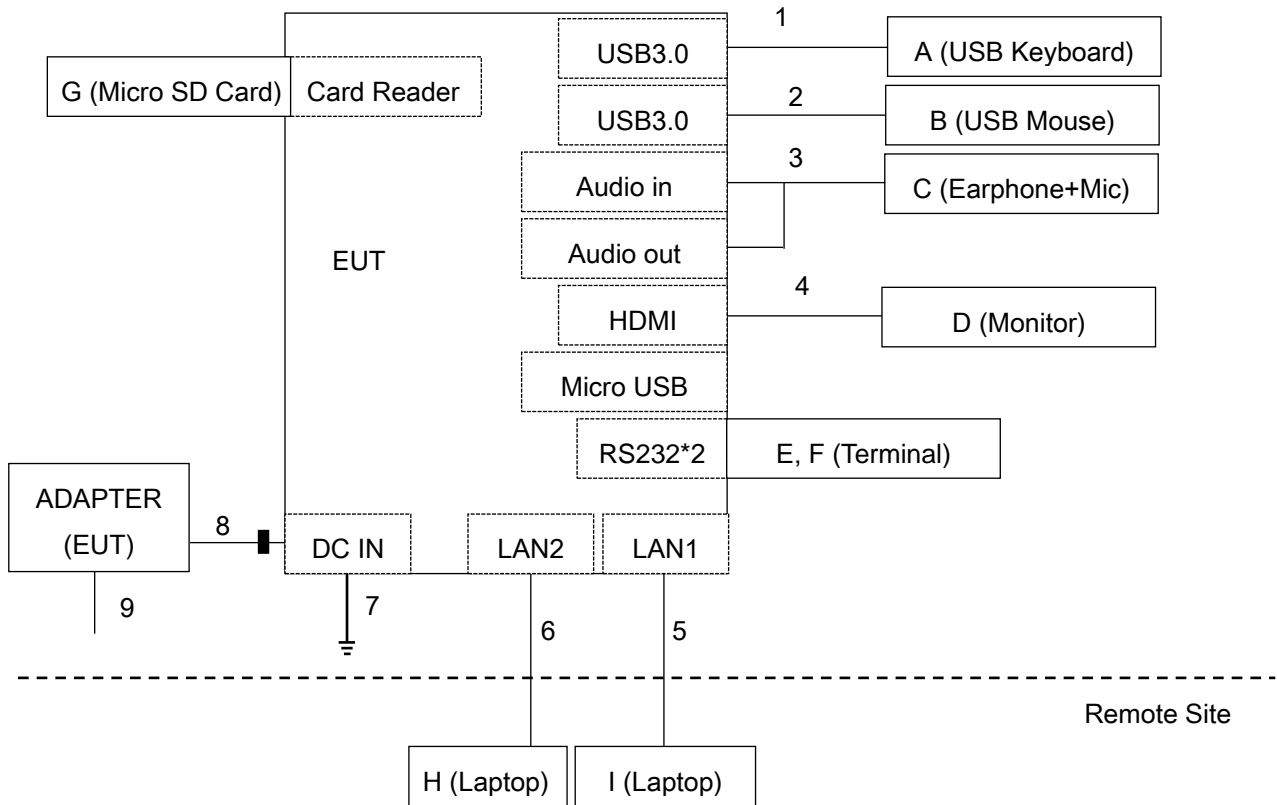
4 Configuration and Connections with EUT

4.1 Connection Diagram of EUT and Peripheral Devices

Emission tests (Harmonics & Flicker excluded):



Harmonics & Flicker & Immunity tests:



4.2 Configuration of Peripheral Devices and Cable Connections

Emission tests (Harmonics & Flicker excluded):

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
A	USB Keyboard	Dell	KB216t	CN-0W33XP-LO300-7CL-191E	N/A	Provided by Lab
B	USB Mouse	DELL	MOCZUL	CN-049TWY-PRC00-77B-0083	N/A	Provided by Lab
C	Microphone	E-books	E-EPB099	N/A	N/A	Provided by Lab
D	Earphone	PHILIPS	SBC HL145	N/A	N/A	Provided by Lab
E	Monitor	ASUS	PA279CV	M7LMTF235958	DoC	Provided by Lab
F	Terminal	N/A	N/A	N/A	N/A	Supplied by applicant
G	Terminal	N/A	N/A	N/A	N/A	Supplied by applicant
H	MICRO SD CARD	Transcend	N/A	N/A	N/A	Supplied by applicant
I	Laptop	LENOVO	T480	PF1EZSA2	N/A	Provided by Lab
J	Laptop	LENOVO	T480	PF1EK03U	N/A	Provided by Lab

ID	Cable Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1	USB cable	1	1.8	Yes	0	Provided by Lab
2	USB cable	1	1.8	Yes	0	Provided by Lab
3	Audio cable	1	2	No	0	Provided by Lab
4	Audio cable	1	1.5	No	0	Provided by Lab
5	HDMI cable	1	2	Yes	0	Provided by Lab, HDMI 2.0 (Brand: Amber, Model: HDMI-AA120)
6	USB (Micro) cable	1	1.2	Yes	0	Provided by Lab
7	RJ45 (Cat. 5e) cable	1	10	Yes	0	Provided by Lab
8	RJ45 (Cat. 5e) cable	1	10	Yes	0	Provided by Lab
9	GND (PE) cable	1	2	No	0	Provided by Lab
10	DC power cable	1	1.5	No	1	Supplied by applicant
11	AC power cable	1	1.8	No	0	Provided by Lab

Harmonics, Flicker, Immunity tests:

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
A	USB Keyboard	Dell	KB212-B	N/A	N/A	Provided by Lab
B	USB Mouse	DELL	MS116p	CN-0145WW-PRC00 -01D-00IA	DoC	Provided by Lab
C	Earphone+Mic	HP	H100	3H100210200191	N/A	Provided by Lab
D	Monitor	Vita	VT-270JTG2	204270JTFE001	DoC	Provided by Lab
E	Terminal	N/A	N/A	N/A	N/A	Supplied by applicant
F	Terminal	N/A	N/A	N/A	N/A	Supplied by applicant
G	MICRO SD CARD	Transcend	N/A	N/A	N/A	Supplied by applicant
H	Laptop	DELL	Latitude 5401	7NPL3X2	DoC	Provided by Lab
I	Laptop	Lenovo	T470	PF-0QW0NQ	N/A	Provided by Lab

ID	Cable Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1	USB 2.0 cable	1	1.8	Yes	0	Provided by Lab
2	USB 2.0 cable	1	1.8	Yes	0	Provided by Lab
3	Audio cable	1	1.8	No	0	Provided by Lab
4	HDMI cable	1	2.0	Yes	0	Provided by Lab, HDMI 2.0 (Brand: Amber, Model: HDMI-AA120)
5	RJ45 (Cat. 5e) cable	1	10	Yes	0	Provided by Lab
6	RJ45 (Cat. 5e) cable	1	10	Yes	0	Provided by Lab
7	GND cable	1	1.8	No	0	Provided by Lab
8	DC power cable	1	1.5	No	1	Supplied by applicant
9	AC power cable	1	1.8	No	0	Provided by Lab

5 Conducted Disturbance at Auxiliary a.c. or d.c. Power Ports

5.1 Limits

Frequency (MHz)	Quasi-peak, (dBuV)
0.15 - 0.5	99
0.5 - 30	93

Notes: 1. The lower limit shall apply at the transition frequencies.
 2. The limit decreases linearly with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.

5.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
50 ohm terminal LYNICS	0900510	E1-011285	2022/9/19	2023/9/18
		E1-011286	2022/9/19	2023/9/18
		E1-011484	2022/6/26	2023/6/25
Attenuator STI	STI02-2200-10	NO.1	2022/9/14	2023/9/13
DC LISN R&S	ESH3-Z6	100219	2022/8/2	2023/8/1
		844950/018	2022/8/2	2023/8/1
DC LISN Schwarzbeck	NNLK 8121	8121-808	2022/4/29	2023/4/28
Isolation Transformer Erika Fiedler	D-65396	017	2022/9/8	2023/9/7
LISN R&S	ENV216	101195	2022/8/1	2023/7/31
		101197	2022/7/5	2023/7/4
	ESH3-Z5	100220	2022/11/24	2023/11/23
LISN Schwarzbeck	NNLK 8121	8121-731	2022/5/26	2023/5/25
	NNLK8129	8129229	2022/6/8	2023/6/7
Receiver R&S	ESCI	100412	2022/8/22	2023/8/21
RF Coaxial Cable Commate	5D-FB	Cable-CO10-01	2023/2/8	2024/2/7
Software BVADT	Cond_V7.3.7.4	N/A	N/A	N/A

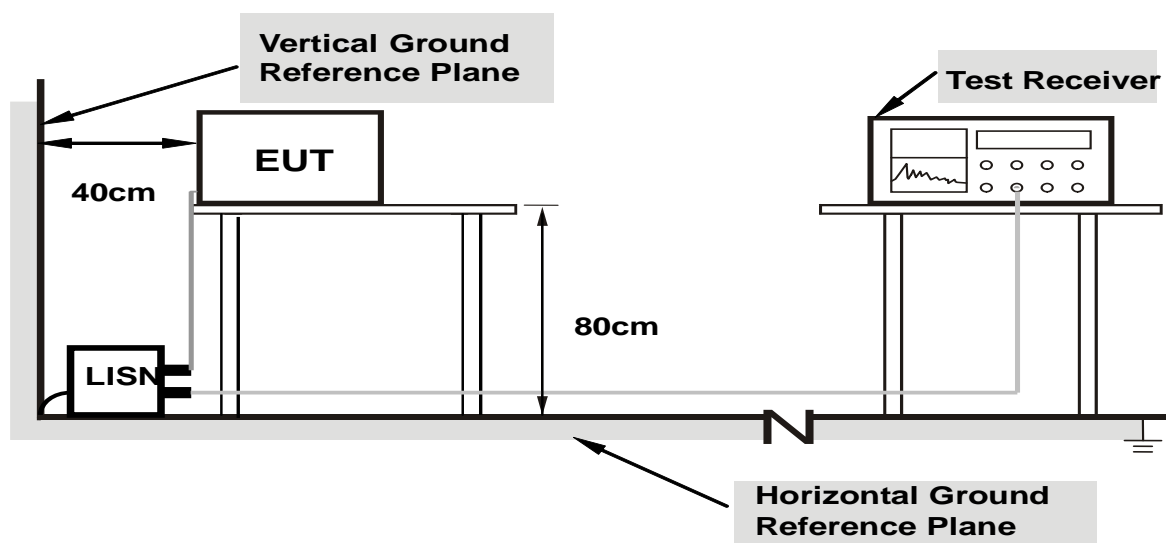
Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
2. The test was performed in Linkou Conduction 10.
3. The VCCI Site Registration No. C-11852.
4. Tested Date: 2023/4/11

5.3 Test Arrangement

- The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). Other support units were connected to the power mains through another LISN. The two LISNs provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- The test results of conducted emissions at mains ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.

Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.



Note: Support units were connected to second LISN.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

5.4 Test Results

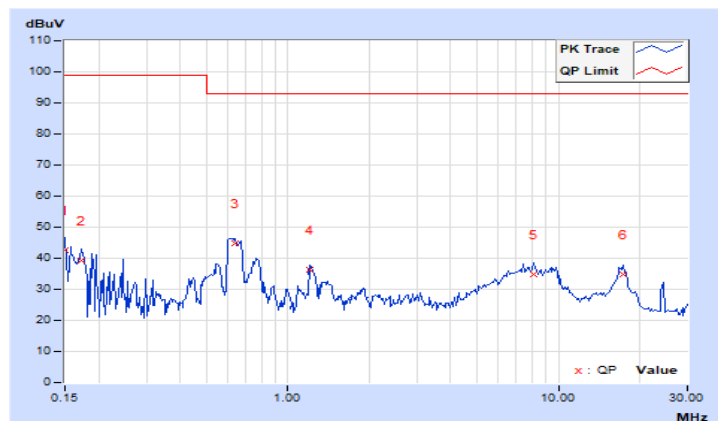
Mode A

Frequency Range	150 kHz ~ 30 MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 9kHz
Input Power	230 Vac, 50 Hz	Environmental Conditions	22°C, 69% RH
Tested by	John Liao		

Phase Of Power : Line (L)						
No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)	Emission Level (dBuV)	Limit (dBuV)	Margin (dB)
			Q.P.	Q.P.	Q.P.	Q.P.
1	0.15001	9.73	33.02	42.75	99.00	-56.25
2	0.17338	9.73	29.64	39.37	99.00	-59.63
3	0.63519	9.74	35.18	44.92	93.00	-48.08
4	1.19922	9.76	26.58	36.34	93.00	-56.66
5	8.10156	9.90	24.95	34.85	93.00	-58.15
6	17.34766	9.93	25.04	34.97	93.00	-58.03

Remarks:

1. Q.P. is abbreviations of quasi-peak individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value

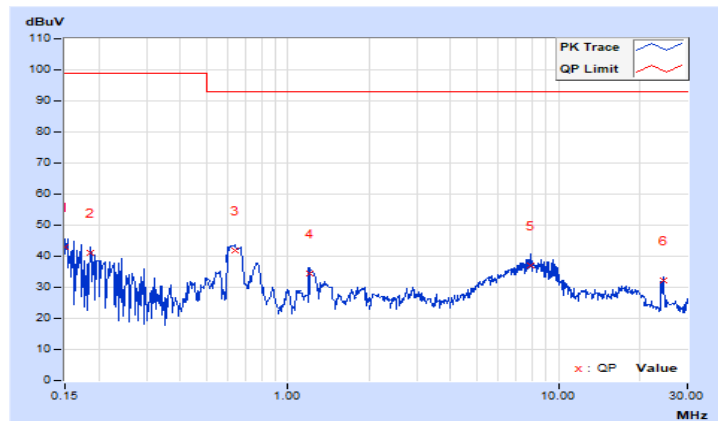


Frequency Range	150 kHz ~ 30 MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 9kHz
Input Power	230 Vac, 50 Hz	Environmental Conditions	22°C, 69% RH
Tested by	John Liao		

Phase Of Power : Neutral (N)						
No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)	Emission Level (dBuV)	Limit (dBuV)	Margin (dB)
			Q.P.	Q.P.	Q.P.	Q.P.
1	0.15001	9.68	33.19	42.87	99.00	-56.13
2	0.18516	9.68	31.47	41.15	99.00	-57.85
3	0.64219	9.68	32.06	41.74	93.00	-51.26
4	1.21026	9.70	24.57	34.27	93.00	-58.73
5	7.91406	9.86	27.16	37.02	93.00	-55.98
6	24.57813	9.97	22.09	32.06	93.00	-60.94

Remarks:

1. Q.P. is abbreviations of quasi-peak individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value



6 Radiated Disturbance up to 1 GHz

6.1 Limits

Frequency (MHz)	dBuV/m (at 10m) / quasi-peak
30 - 230	40
230 - 1000	47

- Notes:
1. The lower limit shall apply at the transition frequencies.
 2. Emission level (dBuV/m) = 20 log Emission level (uV/m).
 3. All emanations from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

6.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
ADT. Tower	AT100	0205	N/A	N/A
ADT. Turn Table	TT100	0205	N/A	N/A
Attenuator Mini-Circuits	UNAT-5+	PAD-ST2-01	2022/10/21	2023/10/20
Bi-log Broadband Antenna Schwarzbeck	VULB9168	9168-303	2022/10/25	2023/10/24
Coupling/Dcoupling Network Schwarzbeck	CDNE-M2	00097	2022/6/1	2023/5/31
	CDNE-M3	00091	2022/6/1	2023/5/31
Preamplifier Agilent	8447D	2944A11062	2023/2/15	2024/2/14
Pre_Amplifier EMCI	EMC9135	980711	2023/3/12	2024/3/11
Pre_Amplifier HP	8447D	2944A08313	2023/2/15	2024/2/14
RF Coaxial Cable Pacific	8D-FB	Cable-ST2-01	2022/10/21	2023/10/20
Software BVADT	Radiated_V7.6.15.9.5	N/A	N/A	N/A
TEST RECEIVER R&S	ESCS 30	100276	2022/4/19	2023/4/18
		100292	2022/8/30	2023/8/29

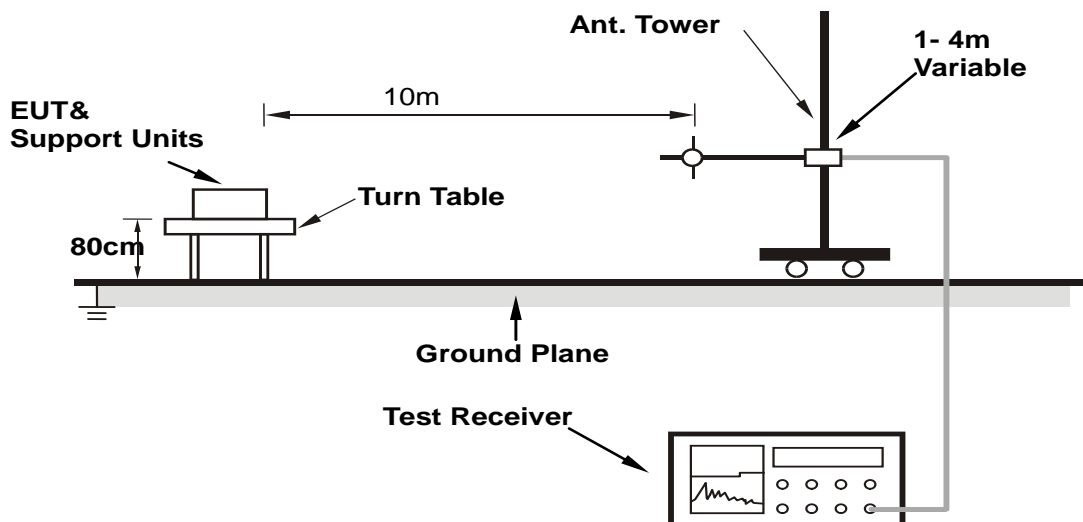
Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
2. The test was performed in Linkou Open Site2 , The test site validated date: 2022/7/16 (NSA)
3. The VCCI Site Registration No. R-10237.
4. Tested Date: 2023/4/11

6.3 Test Arrangement

- The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited test facility. The table was rotated 360 degrees to determine the position of the highest radiation.
- The EUT was set 10 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- The antenna is a broadband antenna, and its height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is up to 1 GHz.

Note: The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120kHz for quasi-peak detection (QP) at frequency up to 1GHz.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

6.4 Test Results

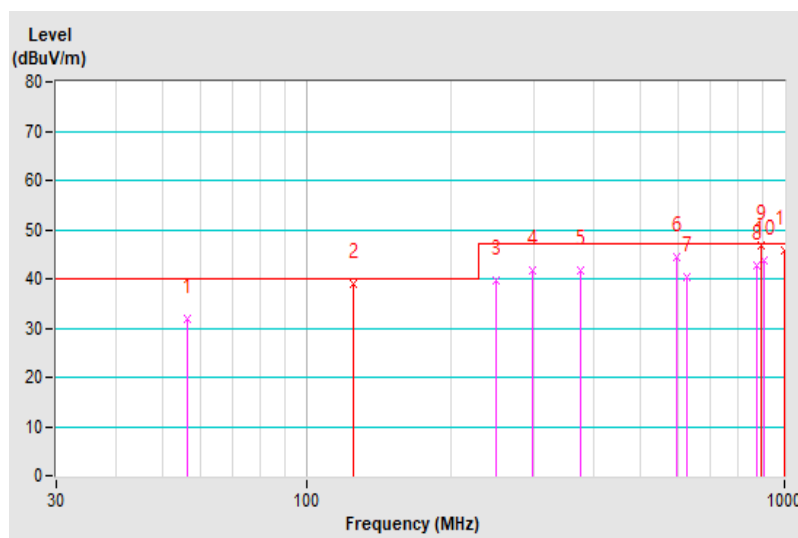
Mode A

Frequency Range	30 MHz ~ 1 GHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 120 kHz
Tested By	Ed Lin	Environmental Conditions	22°C, 75% RH

Antenna Polarity & Test Distance : Horizontal at 10 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	56.56	31.85 QP	40.00	-8.15	3.99 H	156	40.67	-8.82
2	125.01	39.02 QP	40.00	-0.98	4.00 H	73	48.84	-9.82
3	249.99	39.68 QP	47.00	-7.32	3.62 H	118	47.78	-8.10
4	297.01	41.70 QP	47.00	-5.30	2.70 H	140	47.84	-6.14
5	375.00	41.85 QP	47.00	-5.15	2.05 H	210	46.13	-4.28
6	594.02	44.25 QP	47.00	-2.75	1.57 H	210	43.38	0.87
7	625.01	40.32 QP	47.00	-6.68	1.44 H	0	38.51	1.81
8	875.02	42.74 QP	47.00	-4.26	1.00 H	2	35.53	7.21
9	891.01	46.65 QP	47.00	-0.35	1.00 H	76	39.17	7.48
10	903.75	43.56 QP	47.00	-3.44	1.00 H	185	35.71	7.85
11	998.61	45.86 QP	47.00	-1.14	1.00 H	298	36.45	9.41

Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)
– Pre-Amplifier Factor (dB)
3. The other emission levels were very low against the limit.
4. Margin value = Emission level – Limit value

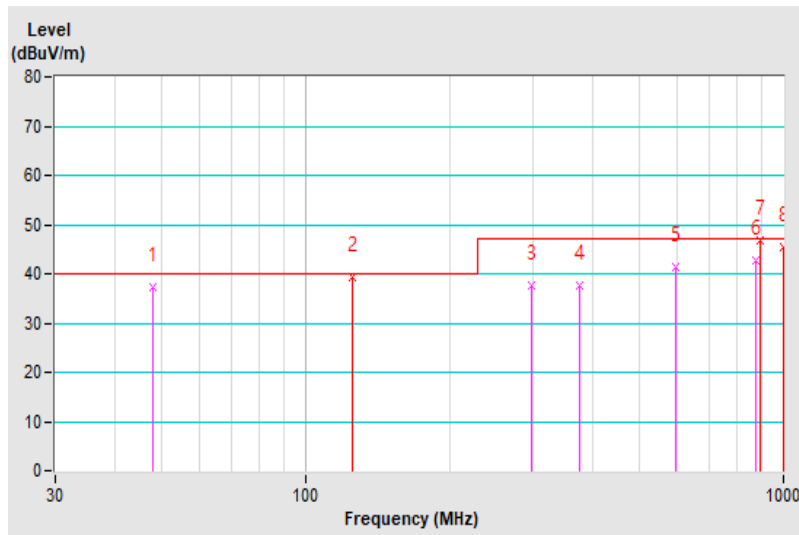


Frequency Range	30 MHz ~ 1 GHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 120 kHz
Tested By	Ed Lin	Environmental Conditions	22°C, 75% RH

Antenna Polarity & Test Distance : Vertical at 10 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	48.01	37.32 QP	40.00	-2.68	1.03 V	163	45.74	-8.42
2	125.01	39.23 QP	40.00	-0.77	1.00 V	335	49.05	-9.82
3	297.02	37.68 QP	47.00	-9.32	1.00 V	360	43.82	-6.14
4	375.02	37.68 QP	47.00	-9.32	1.00 V	217	41.96	-4.28
5	594.03	41.20 QP	47.00	-5.80	1.80 V	323	40.33	0.87
6	875.03	42.68 QP	47.00	-4.32	2.30 V	312	35.47	7.21
7	891.01	46.73 QP	47.00	-0.27	1.84 V	118	39.25	7.48
8	998.65	45.32 QP	47.00	-1.68	1.83 V	155	35.91	9.41

Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)
– Pre-Amplifier Factor (dB)
3. The other emission levels were very low against the limit.
4. Margin value = Emission level – Limit value



7 Radiated Disturbance above 1 GHz

7.1 Limits

Frequency (GHz)	dBuV/m (at 3m)	
	Average	Peak
1 to 3	56	76
3 to 6	60	80

- Notes: 1. The lower limit shall apply at the transition frequencies.
 2. Emission level (dBuV/m) = 20 log Emission level (uV/m).
 3. All emanations from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

Frequency Range (For unintentional radiators)

Highest frequency generated or used in the EUT or on which the EUT operates or tunes (MHz)	Upper frequency of measurement range (MHz)
Below 108	1000
108-500	2000
500-1000	5000
Above 1000	Up to 5 times of the highest frequency or 6 GHz, whichever is less

7.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Attenuator Mini-Circuits	BW-K3-2W44+	PAD-CH7-03	2022/7/7	2023/7/6
	BW-N4W5+	PAD-CH7-02	2022/7/7	2023/7/6
Band Pass Filter MICRO-TRONICS	BRM17690	005	2022/5/26	2023/5/25
Fix tool for Boresight antenna tower BV	BAF-01	4	N/A	N/A
Horn Antenna EMCO	3115	9312-4192	2022/11/13	2023/11/12
Horn Antenna ETS-Lindgren	3117-PA	00215857	2023/2/3	2024/2/2
Horn Antenna Schwarzbeck	BBHA-9170	BBHA9170190	2022/11/13	2023/11/12
Notch Filter MICRO-TRONICS	BRC50703-01	010	2022/5/26	2023/5/25
Pre-amplifier HP	8449B	3008A01292	2023/2/16	2024/2/15
Pre-amplifier (18GHz-40GHz) EMCI	EMC184045B	980175	2022/9/3	2023/9/2
Pre_Amplifier EMCI	EMC0126545	980076	2023/2/16	2024/2/15
	EMC184045B	980235	2023/2/16	2024/2/15
RF Coaxial Cable HUBER SUHNER	SF-102	Cable-CH7(3.6M)-02	2022/7/7	2023/7/6
Software BVADT	Radiated_V8.7.08	N/A	N/A	N/A
Spectrum Keysight	N9020B	MY60110438	2022/12/6	2023/12/5
		MY60112260	2022/5/21	2023/5/20
Test Receiver Agilent	N9038A	MY50010135	2022/8/30	2023/8/29
		MY51210114	2023/1/3	2024/1/2
Turn Table & Tower Max Full	MF7802	MF780208103	N/A	N/A

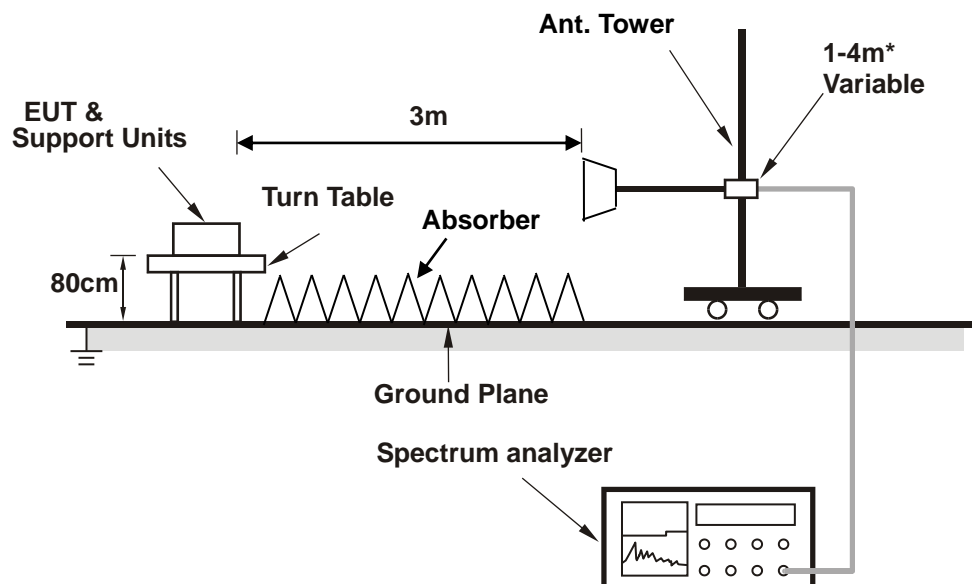
Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
2. The test was performed in Linkou 966 Chamber 2 (CH 7).
3. The VCCI Site Registration No. G-10039.
4. Tested Date: 2023/4/11

7.3 Test Arrangement

- The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- The height of antenna can be varied from one meter to four meters, the height of adjustment depends on the EUT height and the antenna 3dB beamwidth both, to detect the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- The spectrum analyzer system was set to peak and average detect function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz.

Note: The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and video bandwidth is 3MHz for Peak detection (PK) at frequency above 1GHz. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz for Average detection (AV) at frequency above 1GHz.



* :depends on the EUT height and the antenna 3dB beamwidth both.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

7.4 Test Results

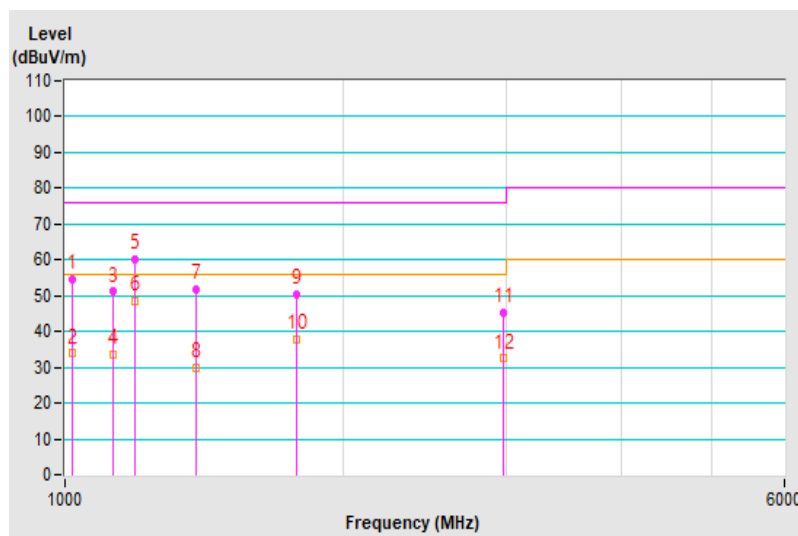
Mode A

Frequency Range	1 GHz ~ 6 GHz	Detector Function & Resolution Bandwidth	Peak (PK) / Average (AV), 1MHz
Tested By	Desmond Chen	Environmental Conditions	20°C, 68% RH

Antenna Polarity & Test Distance : Horizontal at 3 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	1018.38	54.51 PK	76.00	-21.49	1.03 H	318	61.19	-6.68
2	1018.38	33.82 AV	56.00	-22.18	1.03 H	318	40.50	-6.68
3	1128.51	51.16 PK	76.00	-24.84	1.24 H	229	56.61	-5.45
4	1128.51	33.61 AV	56.00	-22.39	1.24 H	229	39.06	-5.45
5	1188.03	60.35 PK	76.00	-15.65	2.14 H	243	65.45	-5.10
6	1188.03	48.65 AV	56.00	-7.35	2.14 H	243	53.75	-5.10
7	1386.14	51.84 PK	76.00	-24.16	1.14 H	85	56.81	-4.97
8	1386.14	29.86 AV	56.00	-26.14	1.14 H	85	34.83	-4.97
9	1782.01	50.31 PK	76.00	-25.69	1.11 H	185	53.63	-3.32
10	1782.01	37.88 AV	56.00	-18.12	1.11 H	185	41.20	-3.32
11	2979.69	45.27 PK	76.00	-30.73	2.47 H	52	45.26	0.01
12	2979.69	32.41 AV	56.00	-23.59	2.47 H	52	32.40	0.01

Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Pre-Amplifier Factor (dB)
3. The other emission levels were very low against the limit.
4. Margin value = Emission level – Limit value

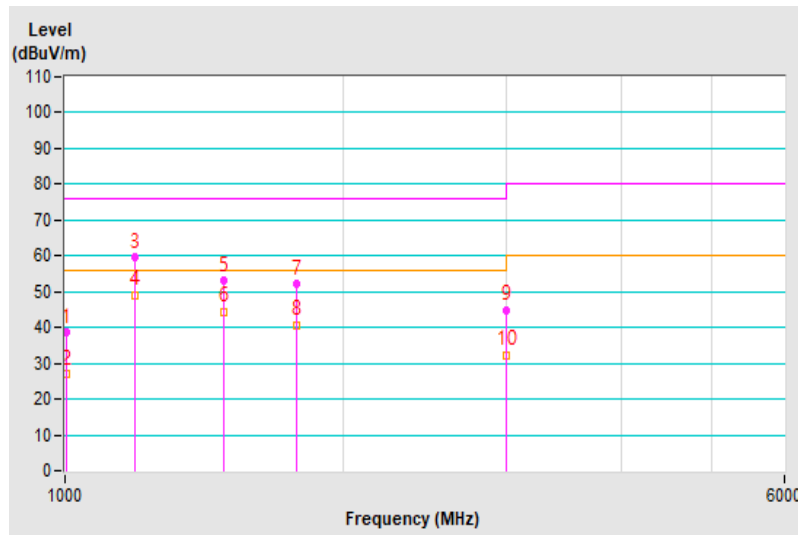


Frequency Range	1 GHz ~ 6 GHz	Detector Function & Resolution Bandwidth	Peak (PK) / Average (AV), 1MHz
Tested By	Desmond Chen	Environmental Conditions	20°C, 68% RH

Antenna Polarity & Test Distance : Vertical at 3 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	1002.78	38.57 PK	76.00	-37.43	1.79 V	356	45.33	-6.76
2	1002.78	26.89 AV	56.00	-29.11	1.79 V	356	33.65	-6.76
3	1188.04	59.50 PK	76.00	-16.50	1.88 V	182	64.60	-5.10
4	1188.04	48.84 AV	56.00	-7.16	1.88 V	182	53.94	-5.10
5	1485.06	52.92 PK	76.00	-23.08	2.33 V	252	57.60	-4.68
6	1485.06	44.34 AV	56.00	-11.66	2.33 V	252	49.02	-4.68
7	1781.96	52.06 PK	76.00	-23.94	1.12 V	177	55.38	-3.32
8	1781.96	40.66 AV	56.00	-15.34	1.12 V	177	43.98	-3.32
9	2999.94	44.81 PK	76.00	-31.19	1.28 V	182	44.68	0.13
10	2999.94	32.30 AV	56.00	-23.70	1.28 V	182	32.17	0.13

Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Pre-Amplifier Factor (dB)
3. The other emission levels were very low against the limit.
4. Margin value = Emission level – Limit value



8 Harmonics Current Measurement

8.1 Limits

Limits for Class A equipment		Limits for Class D equipment		
Harmonic Order n	Max. permissible harmonics current A	Harmonic Order n	Max. permissible harmonics current per watt mA/W	Max. permissible harmonics current A
Odd harmonics		Odd Harmonics only		
3	2.30	3	3.4	2.30
5	1.14	5	1.9	1.14
7	0.77	7	1.0	0.77
9	0.40	9	0.5	0.40
11	0.33	11	0.35	0.33
13	0.21	13	0.30	0.21
15 ≤ n ≤ 39	0.15 x 15/n	15 ≤ n ≤ 39	3.85/n	0.15 x 15/n
Even harmonics				
2	1.08			
4	0.43			
6	0.30			
8 ≤ n ≤ 40	0.23 x 8/n			

- Notes: 1. Class A and Class D are classified according to section 5 of EN 61000-3-2.
 2. According to section 7 of EN 61000-3-2, the above limits for all equipment except for lighting equipment having an active input power > 75 W and no limits apply for equipment with an active input power up to and including 75 W.

8.2 Classification of Equipment

Class A	Class B	Class C	Class D
Balanced three-phase equipment; Household appliances excluding equipment as Class D; Tools excluding portable tools; Dimmers for incandescent lamps; Audio equipment; Equipment not specified in one of the three other classes.	Portable tools; Arc welding equipment which is not professional equipment.	Lighting equipment.	Equipment having a specified power less than or equal to 600 W of the following types: Personal computers and personal computer monitors; Television receivers; Refrigerators and freezers having one or more variable-speed drives to control compressor motor(s).

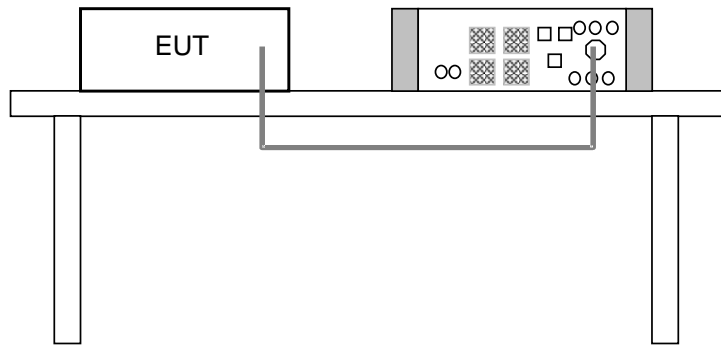
8.3 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Harmonics and Flicker Analyzer TESEQ	PROFLINE 2105	1632A00983&1639A01863	2022/6/8	2023/6/7
Software	CTS 4	N/A	N/A	N/A

- Notes:
- The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
 - The test was performed in Linkou EMS Room No.1.
 - Tested Date: 2023/4/12

8.4 Test Arrangement

- The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

8.5 Test Results

Mode A

Test Duration	5 min	Fundamental Voltage / Ampere	232.12 Vrms / 0.092 Arms
Power Consumption	12.9 W	Power Frequency	50 Hz
Power Factor	0.624	Environmental Conditions	20°C, 74% RH
Tested By	Sean Chou		

Notes:

- Limits are not specified for equipment with a rated power of 75W or less (other than lighting equipment).
- According to EN 61000-3-2 the manufacturer shall specify the power of the apparatus. This value shall be used for establishing limits. The specified power shall be within +/-10% of the measured power.

9 Voltage Fluctuations and Flicker Measurement

9.1 Limits

Test item	Limit	Note
P_{st}	1.0	P_{st} : short-term flicker severity.
P_{lt}	0.65	P_{lt} : long-term flicker severity.
T_{max} (ms)	500	T_{max} : maximum time duration during the observation period that the voltage deviation $d(t)$ exceeds the limit for d_c .
d_{max} (%)	4	d_{max} : maximum absolute voltage change during an observation period.
d_c (%)	3.3	d_c : maximum steady state voltage change during an observation period.

9.2 Test Instruments

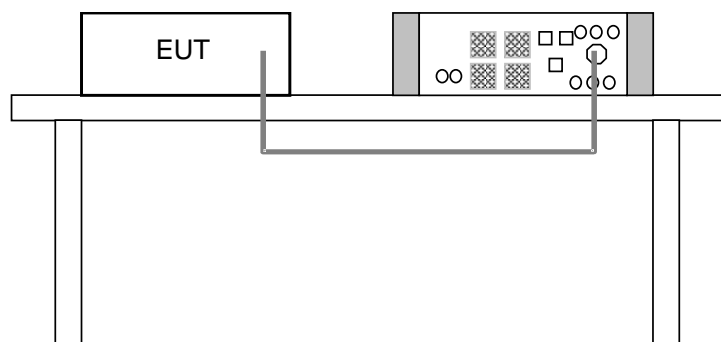
Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Harmonics and Flicker Analyzer TESEQ	PROFLINE 2105	1632A00983&1639A01863	2022/6/8	2023/6/7
Software	CTS 4	N/A	N/A	N/A

Notes:

- The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
- The test was performed in Linkou EMS Room No.1.
- Tested Date: 2023/4/12

9.3 Test Arrangement

- The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

9.4 Test Results

Mode A

Observation (Tp)	10 min		
Input Power	230 Vac, 50 Hz	Environmental Conditions	20°C, 74% RH
Tested By	Sean Chou		

Test Parameter	Measurement Value	Limit	Remarks
P_{st}	0.261	1.00	Pass
P_{lt}	0.114	0.65	Pass
T_{max} (ms)	0.000	500	Pass
d_{max} (%)	0.000	4.00	Pass
d_c (%)	0.000	3.30	Pass

Notes:

- P_{st} means short-term flicker indicator.
- P_{lt} means long-term flicker indicator.
- T_{max} means accumulated time value of $d(t)$ with a deviation exceeding 3.3 %.
- d_{max} means maximum relative voltage change.
- d_c means maximum relative steady-state voltage change.

10 Electrostatic Discharge Immunity Test (ESD)

10.1 Test Specification

Basic Standard:	EN 61000-4-2
Discharge Impedance:	330 ohm / 150 pF
Discharge Voltage:	Air Discharge: $\pm 2, \pm 4, \pm 8$ kV (Direct) Contact Discharge: $\pm 2, \pm 4, \pm 6$ kV (Indirect & Direct)
Number of Discharge:	Minimum 20 times at each test point
Discharge Mode:	Single Discharge
Discharge Period:	1-second minimum

10.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Electronic Discharge Simulator Noiseken	ESS-2000	ESS0382041	2022/10/7	2023/10/6
Electrostatic Analog Tester TESEQ	NSG 438	1875	2022/11/11	2023/11/10
ESD Generator EM Test	Dito//DM-150/330//DM-150/330-rfci	P1315117252/P1317117852	2022/7/7	2023/7/6
ESD Simulator EM TEST	Dito	V0707102251	2023/3/24	2024/3/23
ESD Simulator KeyTek	MZ15/EC	0504259	2022/11/8	2023/11/7
ESD Simulator TESEQ	NSG 438	1364	2022/12/2	2023/12/1

Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
2. The test was performed in Linkou ESD Room No.03.
3. Tested Date: 2023/4/26

10.3 Test Arrangement

- Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- The time interval between two successive single discharges was at least 1 second.
- The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- At least ten single discharges (in the most sensitive polarity) were applied to the **Horizontal Coupling Plane** at points on each side of the EUT. The ESD generator was positioned at a distance of 0.1 meters from the EUT with the discharge electrode touching the **HCP**.
- At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the **Vertical Coupling Plane** in sufficiently different positions that the four faces of the EUT were completely illuminated. The **VCP** (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the EUT.

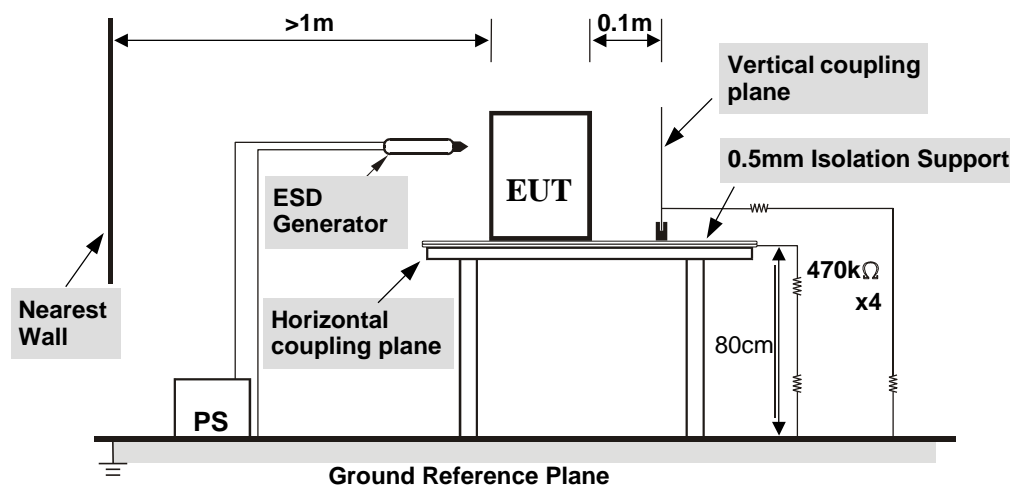


TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the **Ground Reference Plane**. The **GRP** consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A **Horizontal Coupling Plane** (1.6m x 0.8m) was placed on the table and attached to the **GRP** by means of a cable with $940\text{k}\Omega$ total impedance. The equipment under test, was installed in a representative system as described in section 7 of EN 61000-4-2, and its cables were placed on the **HCP** and isolated by an insulating support of 0.5mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

10.4 Test Results

Mode A

Input Power	230Vac, 50 Hz	Tested by	Aga Lin
Environmental Conditions	23 °C, 50 % RH, 1007 mbar		

Test Results of Direct Application

Discharge Level (kV)	Polarity (+/-)	Test Point	Contact Discharge	Air Discharge	Performance Criterion
2	+/-	1, 15	Note 1	---	A
4	+/-	1, 15	Note 2	---	B
6	+/-	1, 15	Note 2, Note 3	---	B
2, 4	+/-	2, 3, 4	Note 1	---	A
2, 4	+/-	5 ~ 9, 16	---	Note 1	A
8	+/-	5 ~ 9, 16	---	Note 2, Note 3	B
2, 4, 8	+/-	10 ~ 14, 17, 18	---	Note 1	A

Description of test points of direct application: Please refer to following page for representative mark only.

Test Results of Indirect Application

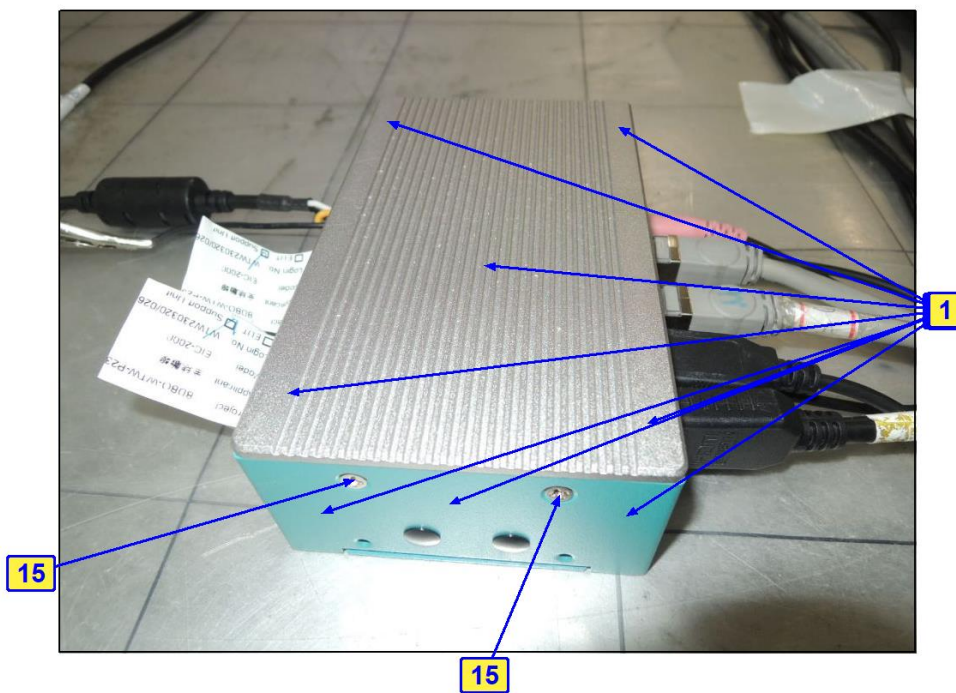
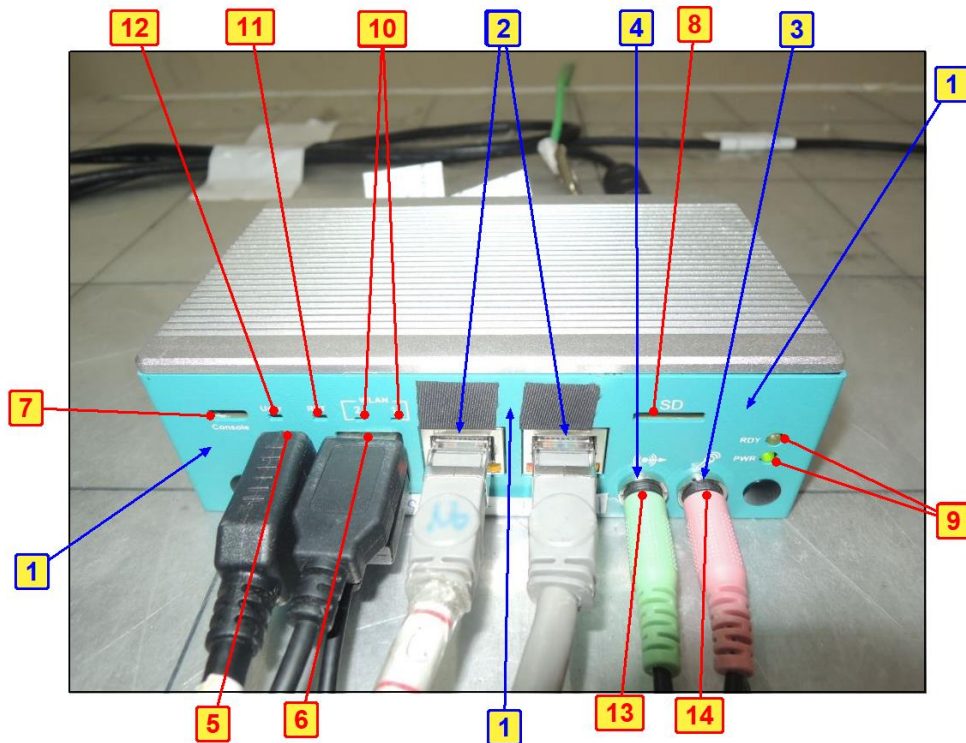
Discharge Level (kV)	Polarity (+/-)	Test Point	Horizontal Coupling Plane	Vertical Coupling Plane	Performance Criterion
2	+/-	Four Side	Note 1	Note 1	A
4	+/-	Four Side	Note 2	Note 2	B
6	+/-	Four Side	Note 2, Note 3	Note 2, Note 3	B

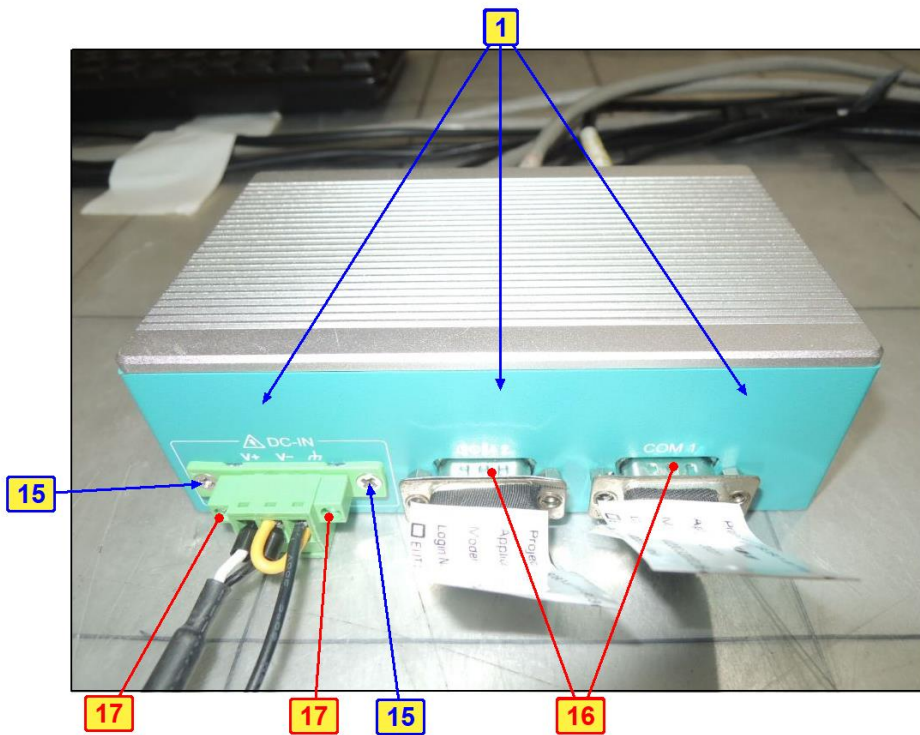
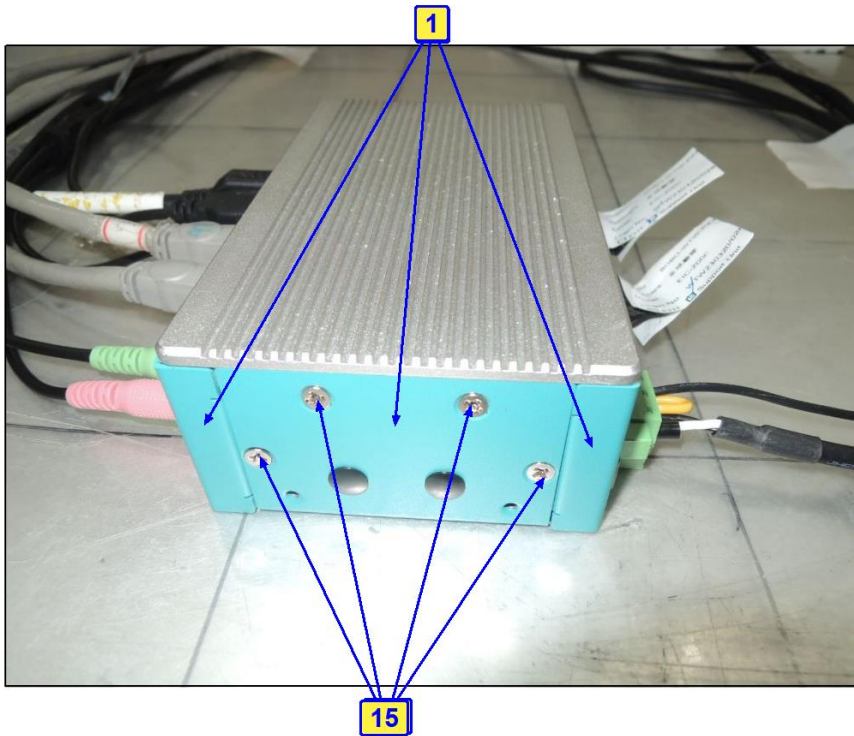
Description of test points of indirect application:

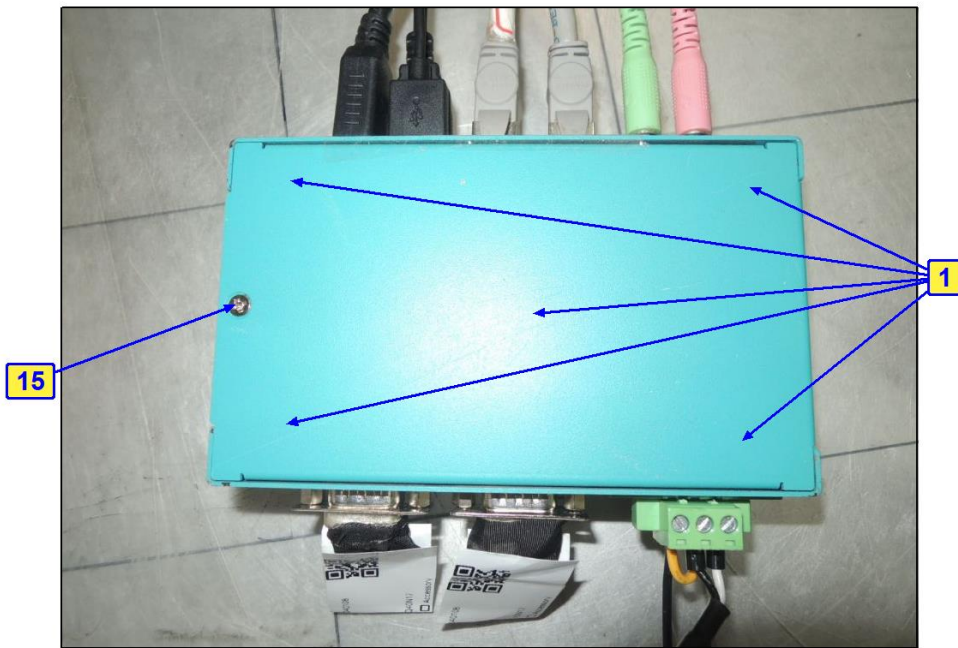
1. Front side 2. Rear side 3. Right side 4. Left side

- Note: 1. The EUT is operated normal during the test.
 2. There are horizontal bars on the screen during the test, but self-recoverable after the test.
 3. The image on the screen disappeared during the test, but self-recoverable after the test.

Description of Test Points







11 Radio-frequency Electromagnetic Field Immunity Test (RS)

11.1 Test Specification

Basic Standard:	EN 61000-4-3
Frequency Range, Field Strength:	80-800 MHz, 20V/m ¹
	800-1000 MHz, 20V/m
	1400-2000 MHz, 10V/m
	2000-2700 MHz, 5V/m
Modulation:	5100-6000 MHz, 3V/m
	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of preceding frequency value
Polarity of Antenna:	Horizontal and Vertical
Antenna Height:	1.5m
Dwell Time:	3 seconds

Note 1: This limit applies to equipment mounted in the passenger compartments, drivers cab or external to the rolling stock (roof, underframe). For equipment mounted in all other areas a severity level of 10 V/m may be used.

11.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
* Broadband Field Meter Narda	NBM-550	B-0872	2022/3/18	2024/3/17
Amplifier BONN	BSA 0125-800	1912556	N/A	N/A
Amplifier TESTQ	CBA 1G-275	T44344	N/A	N/A
Audio analyzer R&S	UPV	104565	2022/5/10	2023/5/9
Band pass filter B&K	WH3278	N/A	2022/6/5	2023/6/4
BiconiLog Antenna EMCO	3141	1001	N/A	N/A
CHANCE MOST Full Anechoic Chamber (9x5x3m)	Chance Most	RS-002	2023/2/3	2024/2/2
Controller AR	SC1000M3	305910	N/A	N/A
Ear Simulator Telephonometry B&K	4185	2553594	N/A	N/A
High Gain Horn Antenna AR	AT4010	0329800	N/A	N/A
LOG ANTENNA Schwarzbeck	Schwarzbeck Stlp 9149	9149-260	N/A	N/A
Log-Periodic Antenna AR	AT6080	0329465	N/A	N/A

Power Amplifier AR	35S4G8AM4	0326094	N/A	N/A
	100S1G4M3	0329249	N/A	N/A
Power Meter BOONTON	4232A	94901	2022/6/6	2023/6/5
Power Sensor BOONTON	51011-EMC	32807	2022/6/6	2023/6/5
		32832	2022/6/6	2023/6/5
Pressure-field Microphone B&K	4192	3190854	2022/12/12	2023/12/11
Signal Generator Agilent	E8257D	MY48050465	2022/6/29	2023/6/28
Software BVADT	RS_V7.6	N/A	N/A	N/A
Software	ABMS_V7.4.3	N/A	N/A	N/A
Two channel microphone conditioning amplifier B&K	2690 A OS2	2645274	2022/6/5	2023/6/4

Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
2. * The calibration interval of the above test instruments is 24 months and the calibrations are traceable to NML/ROC and NIST/USA
3. The test was performed in Linkou RS Room No.02.
4. Tested Date: 2023/4/28

11.3 Test Arrangement

The test procedure was in accordance with EN 61000-4-3.

- The testing was performed in a fully anechoic chamber.
- The frequency ranges and field strength levels are 80-800 MHz, 20V/m, 800-1000 MHz, 20V/m, 1400-2000 MHz, 10V/m, 2000-2700 MHz, 5V/m and 5100-6000 MHz, 3V/m with the signal 80% amplitude modulated with a 1kHz sine wave.
- The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

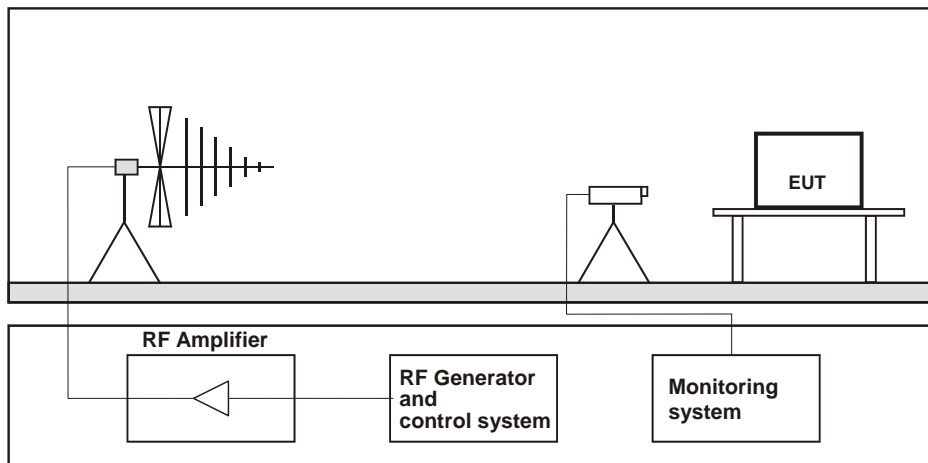


Table-top Equipment

The EUT installed in a representative system as described in section 7 of EN 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

11.4 Test Results

Mode A

Input Power	230Vac, 50 Hz	Tested by	Michael Cheng
Environmental Conditions	27 °C, 62 % RH		

Frequency (MHz)	Polarity	Azimuth(°)	Applied Field Strength		Observation	Performance Criterion
			(V/m)	Modulation		
80 - 800	V&H	0, 90, 180, 270	20	80% AM (1kHz)	Note	A
800 - 1000	V&H	0, 90, 180, 270	20	80% AM (1kHz)	Note	A
1400 - 2000	V&H	0, 90, 180, 270	10	80% AM (1kHz)	Note	A
2000 - 2700	V&H	0, 90, 180, 270	5	80% AM (1kHz)	Note	A
5100 - 6000	V&H	0, 90, 180, 270	3	80% AM (1kHz)	Note	A

Note: The EUT is operated normal during the test.

12 Electrical Fast Transient/Burst Immunity Test (EFT)

12.1 Test Specification

Basic Standard:	EN 61000-4-4
Test Voltage:	Signal & communication, process measurement & control ports: $\pm 2\text{kV}$, Capacitive clamp Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage $\leq 400\text{ Vrms}$): $\pm 2\text{kV}$
Impulse Repetition Frequency:	5kHz
Impulse Wave Shape:	5/50 (T_r/T_h) ns
Burst Duration:	15 ms
Burst Period:	300 ms
Test Duration:	1 min.

12.2 Test Instruments

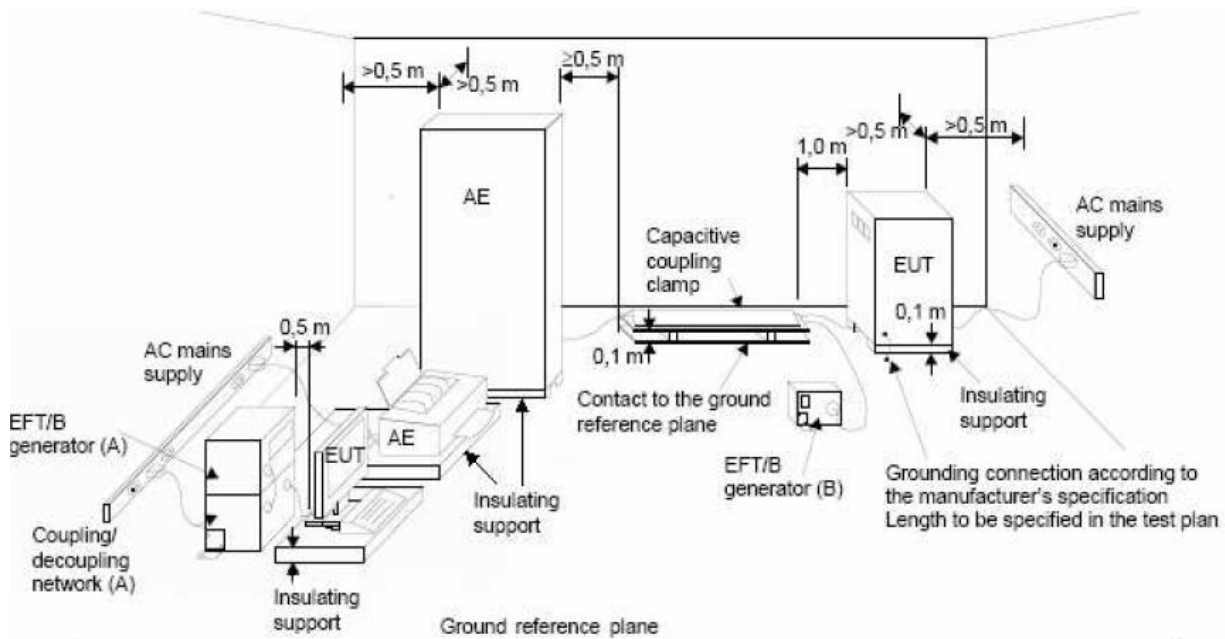
Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Burst generator Haefely	PEFT 4010	154954	2023/3/24	2024/3/23

Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
2. The test was performed in Linkou EFT Room.
3. Tested Date: 2023/4/14

12.3 Test Arrangement

- Both positive and negative polarity discharges were applied.
- The distance between any coupling devices and the EUT should be 0.5 m for table-top equipment testing, and 1.0 m for floor standing equipment.
- The duration time of each test sequential was 1 minute.
- The transient/burst waveform was in accordance with EN 61000-4-4, 5/50 ns.



NOTE:

- location for supply line coupling
- location for signal lines coupling

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

12.4 Test Results

Mode A

Input Power	230Vac, 50 Hz	Tested by	Michael Cheng
Environmental Conditions	23 °C, 65 % RH		

Battery referenced ports (except at the output of energy sources),
 Auxiliary a.c. power input ports (rated voltage \leq 400 Vrms)

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
2	L	+/-	Note	A
2	N	+/-	Note	A
2	PE	+/-	Note	A
2	L-N-PE	+/-	Note	A

Signal & communication, process measurement & control ports

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
2	LAN	+/-	Note	A

Note: The EUT is operated normal during the test.

13 Surge Immunity Test

13.1 Test Specification

Basic Standard:	EN 61000-4-5
Wave-Shape:	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms): 1.2/50 μ s Open Circuit Voltage 8/20 μ s Short Circuit Current
Test Voltage:	Line to line: ± 0.5 kV, ± 1 kV, Line to ground: ± 0.5 kV, ± 1 kV, ± 2 kV output impedance of 42 Ω (40 Ω and 2 Ω generator) and a coupling capacitance of 0,5 μ F
AC Phase Angle (degree):	0°, 90°, 180°, 270°
Pulse Repetition Rate:	1 time / 20 sec.
Number of Tests:	5 positive and 5 negative at selected points

13.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
CDN for Unshielded Unsymmetrical Signal & Data Lines TESEQ	CDN117	40144	2022/8/23	2023/8/22
Coupling Decoupling Network EMC-Partner	CDN-UTP8	045	2022/8/2	2023/8/1
Coupling Decoupling Network TESEQ	CDN HSS-2	41009	2023/4/18	2024/4/17
Surge Coupling Decoupling Network TESEQ	CDN 118-T8	40386	2022/8/23	2023/8/22
Surge&EFT Generators TESEQ	NSG 3060	1572	2023/4/18	2024/4/17

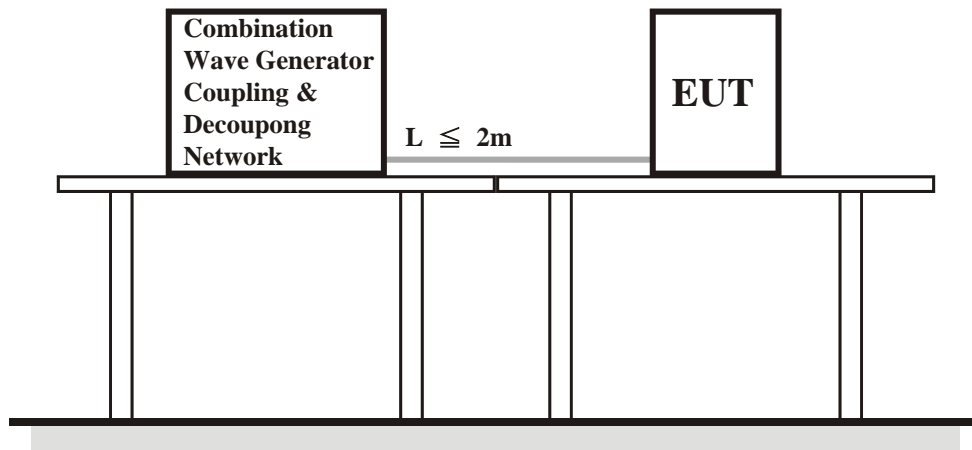
Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
2. The test was performed in Linkou EMS Room No.02.
3. Tested Date: 2023/4/25

13.3 Test Arrangement

The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

For double-insulated products without PE or external earth connections, the test shall be done in a similar way as for grounded products but without adding any additional external grounded connections. If there are no other possible connections to earth, line-to-ground tests may be omitted.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

13.4 Test Results

Mode A

Input Power	230Vac, 50 Hz	Tested by	Aga Lin
Environmental Conditions	23 °C, 71 % RH		

Battery referenced ports (except at the output of energy sources),
 Auxiliary a.c. power input ports (rated voltage ≤ 400 Vrms)

Voltage (kV)	Test Point	Azimuth(°)	Polarity (+/-)	Observation	Performance Criteria
0.5, 1(42 Ω+0.5µF)	L-N	0,90,180,270	+/-	Note	A
0.5, 1, 2(42 Ω+0.5µF)	L-PE	0,90,180,270	+/-	Note	A
0.5, 1, 2(42 Ω+0.5µF)	N-PE	0,90,180,270	+/-	Note	A

Note: The EUT is operated normal during the test.

14 Immunity to Conducted Disturbances Induced by RF Fields (CS)

14.1 Test Specification

Basic Standard:	EN 61000-4-6
Frequency Range:	0.15 MHz - 80 MHz
Voltage Level:	Battery referenced ports (except at the output of energy sources), Auxiliary a.c. power input ports (rated voltage \leq 400 Vrms), Signal & communication, process measurement & control ports: 10 V
Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of preceding frequency value
Dwell Time	3 seconds

14.2 Test Instruments

Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
Audio analyzer R&S	UPV	104565	2022/5/10	2023/5/9
CDN FCC	FCC-801-M5-50A	100018	2023/1/17	2024/1/16
CDN TESEQ	CDN S200	53490	2023/2/23	2024/2/22
	CDN S400	52115	2023/2/23	2024/2/22
CDN Calibration Kit TESEQ	CDN T8S	29459	2023/2/21	2024/2/20
CDN M2-16Amp FCC	FCC-801-M2-16A	01047	2023/2/22	2024/2/21
Coupling Decoupling Network TESEQ	CDN M432S	56519	2023/2/22	2024/2/21
	CDN S751A	56435	2023/2/20	2024/2/19
		56436	2023/2/21	2024/2/20
	CDN ST08A	56525	2023/2/20	2024/2/19
		56527	2023/2/20	2024/2/19
	CDN T2A-10	54942	2023/2/21	2024/2/20
	CDN T8-10	40376	2023/2/21	2024/2/20
	CDN T8-230	56641	2023/2/21	2024/2/20
		56642	2023/2/21	2024/2/20
CDN T800	34428	2023/2/21	2024/2/20	
CDN T400A	49918	2023/2/22	2024/2/21	
Coupling/Dcoupling Network EM TEST	CDN M1/32A	306508	2023/2/22	2024/2/21
Coupling/Dcoupling Network TESEQ	CDN M232	37702	2023/2/22	2024/2/21
	CDN M332	41256	2023/2/22	2024/2/21
		41258	2023/2/22	2024/2/21
CS Power Amplifier ETS-Lindgren	8100-010	00163535	N/A	N/A
Current Clamp FCC	F-120-9A	361	2022/8/17	2023/8/16
Ear Simulator Telephonometry B&K	4185	2553594	N/A	N/A

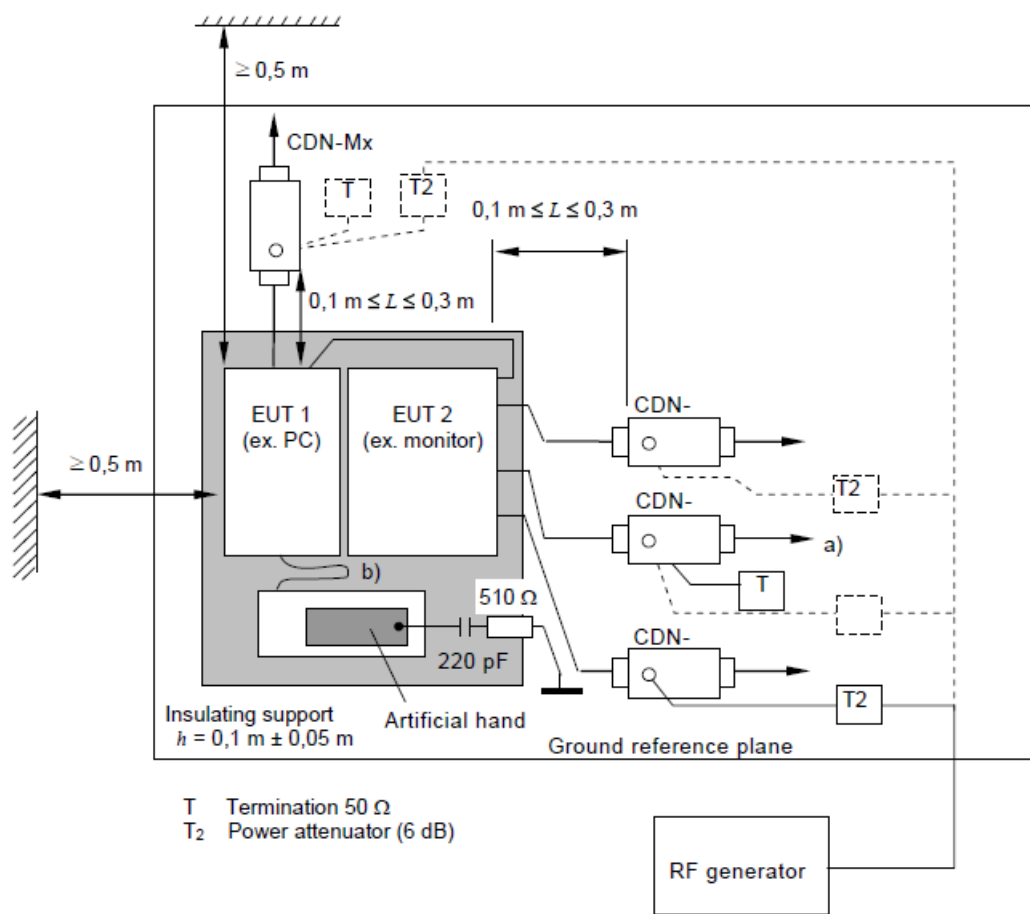
Description Manufacturer	Model No.	Serial No.	Calibrated Date	Calibrated Until
FCC EM Injection Clamp FCC	F-203I-23mm	455	N/A	N/A
Mouth Simulator B&K	4227	2630632	N/A	N/A
POWER AMPLIFIER B&K	2716C	2610979	N/A	N/A
Power Meter R & S	NRVD	837794/040	2022/10/18	2023/10/17
Power Sensor R & S	NRV-Z5	837878/039	2022/10/18	2023/10/17
Pressure-field Microphone B&K	4192	2735407	N/A	N/A
SIGNAL GENERATOR R&S	SML03	101364	2022/8/16	2023/8/15
Software BVADT	ABMS_ V7.4.3	N/A	N/A	N/A
Software BVADT	BVADT_CS_V7.6.6	N/A	N/A	N/A
Two channel microphone conditioning amplifier B&K	2690 OS2	3001996	2022/11/15	2023/11/14
Wireless Connection Tester R&S	CMW270	101075	N/A	N/A

Notes:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
2. The test was performed in Linkou CS Room No.1.
3. Tested Date: 2023/4/25

14.3 Test Arrangement

- The EUT shall be tested within its intended operating and climatic conditions.
- An artificial hand was placed on the hand-held accessory and connected to the ground reference plane.
- One of the CDNs not used for injection was terminated with 50 ohm, providing only one return path. All other CDNs were coupled as decoupling networks.
- The frequency range is swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal is modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. Where the frequency is swept incrementally, the step size shall not exceed 1 % of the preceding frequency value.
- Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.



IEC 2606/13

- Note:**
- The EUT clearance from any metallic obstacles shall be at least 0,5 m.
 - Interconnecting cables (≤ 1 m) belonging to the EUT shall remain on the insulating support.
 - The equipment to be tested is placed on an insulating support of 0.1 meters height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

14.4 Test Results

Mode A

Input Power	230Vac, 50 Hz	Tested by	Aga Lin
Environmental Conditions	23 °C, 72 % RH		

Input AC power port							
Frequency (MHz)	Level (V rms)	Modulation	Tested Line	Injection Method	Return Path	Observation	Performance Criteria
0.15 – 80	10	80% AM (1kHz)	AC	CDN-M3	CDN-M1	Note	A

Wired network and signal/ control port							
Frequency (MHz)	Level (V rms)	Modulation	Tested Line	Injection Method	Return Path	Observation	Performance Criteria
0.15 – 80	3	80% AM (1kHz)	LAN	CDN-T8	CDN-M1	Note	A

Note: The EUT is operated normal during the test.

15 Pictures of Test Arrangements

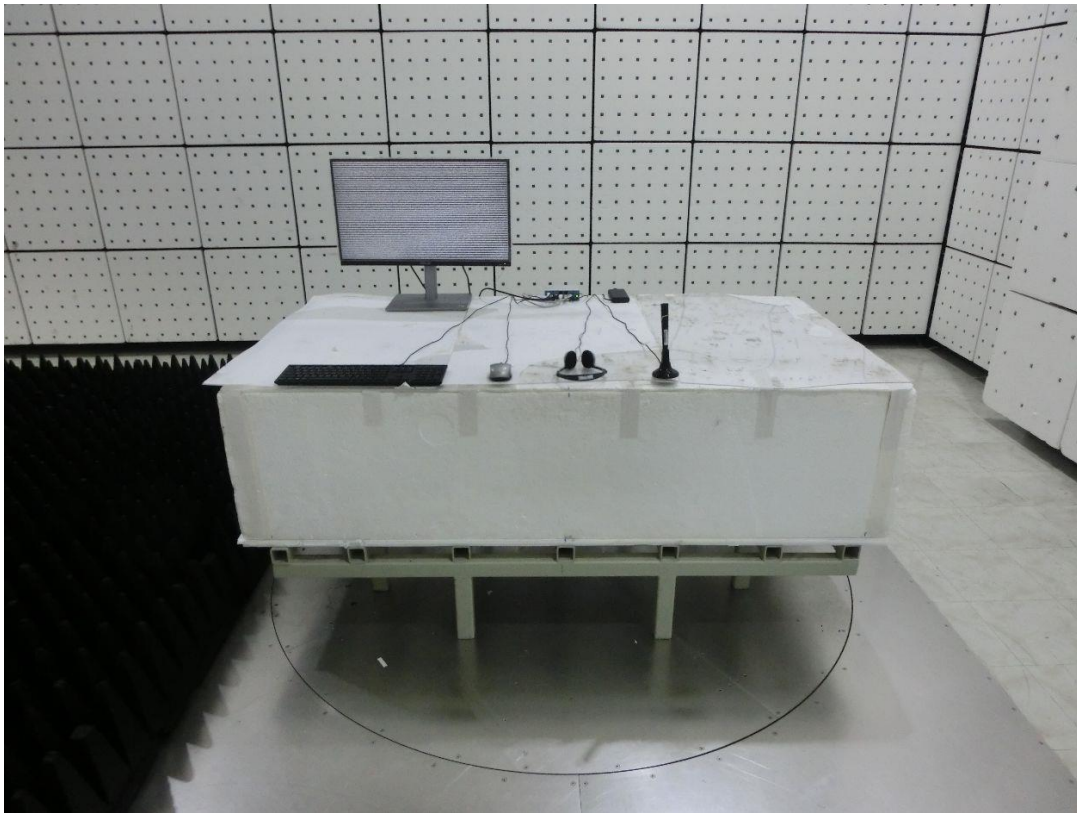
15.1 Conducted Disturbance at Auxiliary a.c. or d.c. power ports



15.2 Radiated Disturbance up to 1 GHz



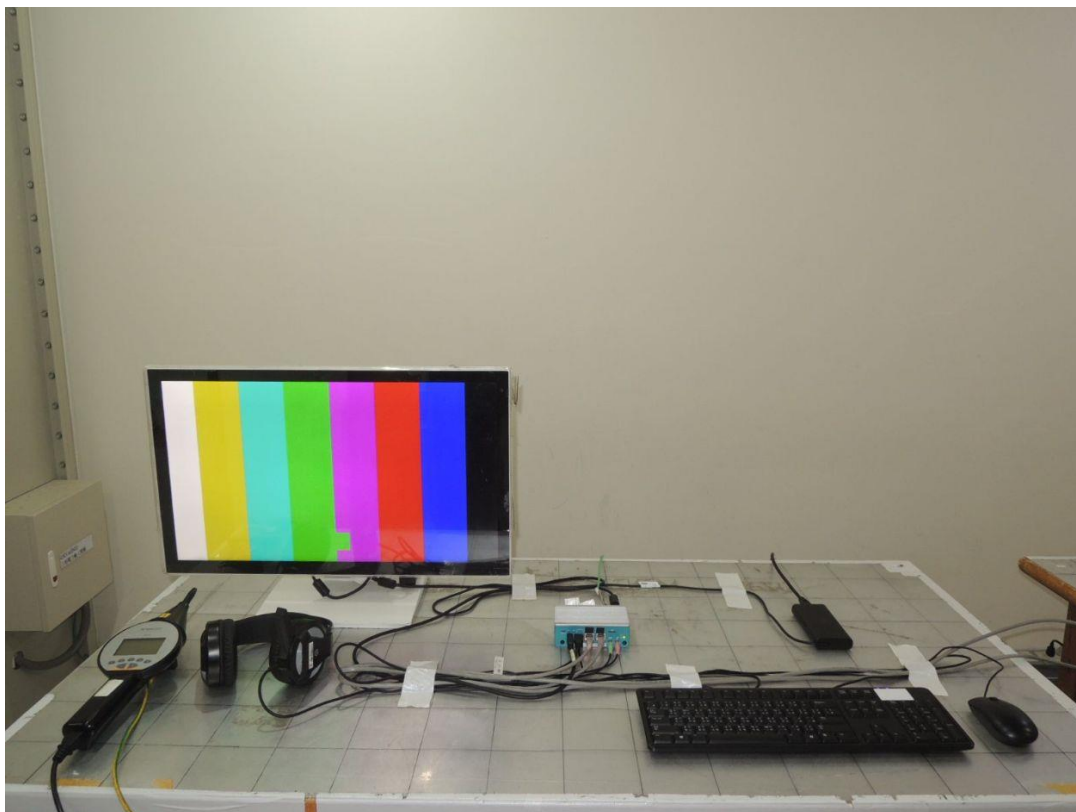
15.3 Radiated Disturbance above 1 GHz



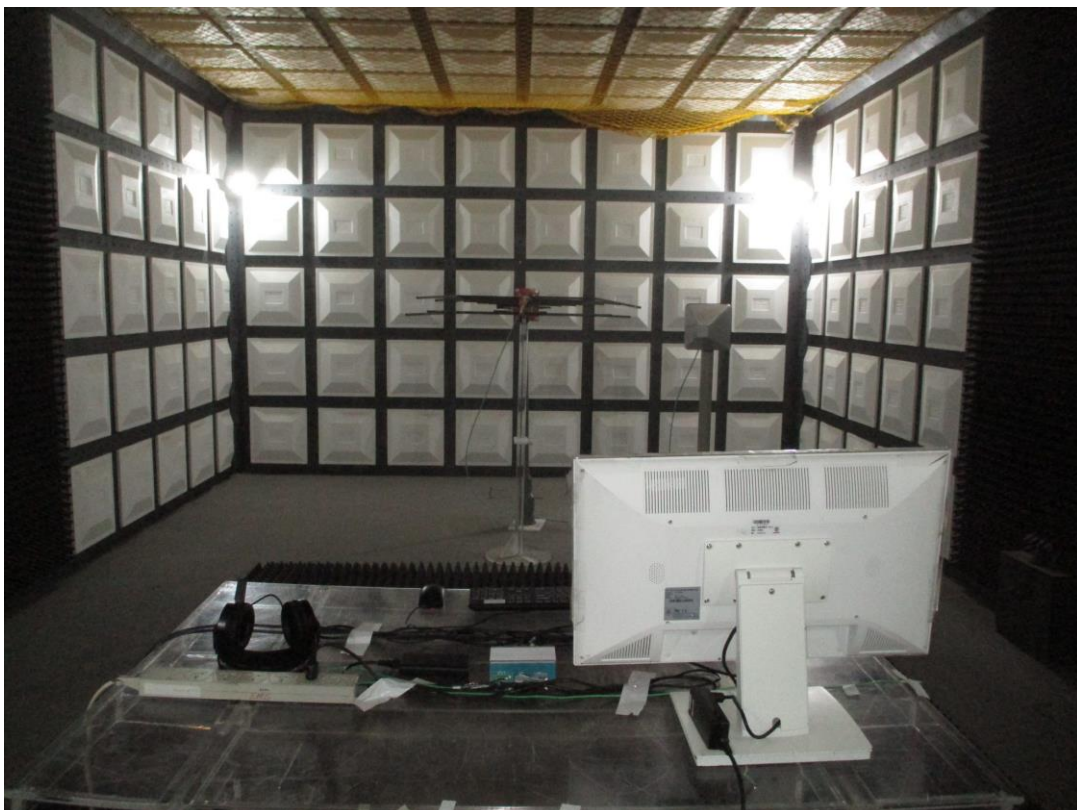
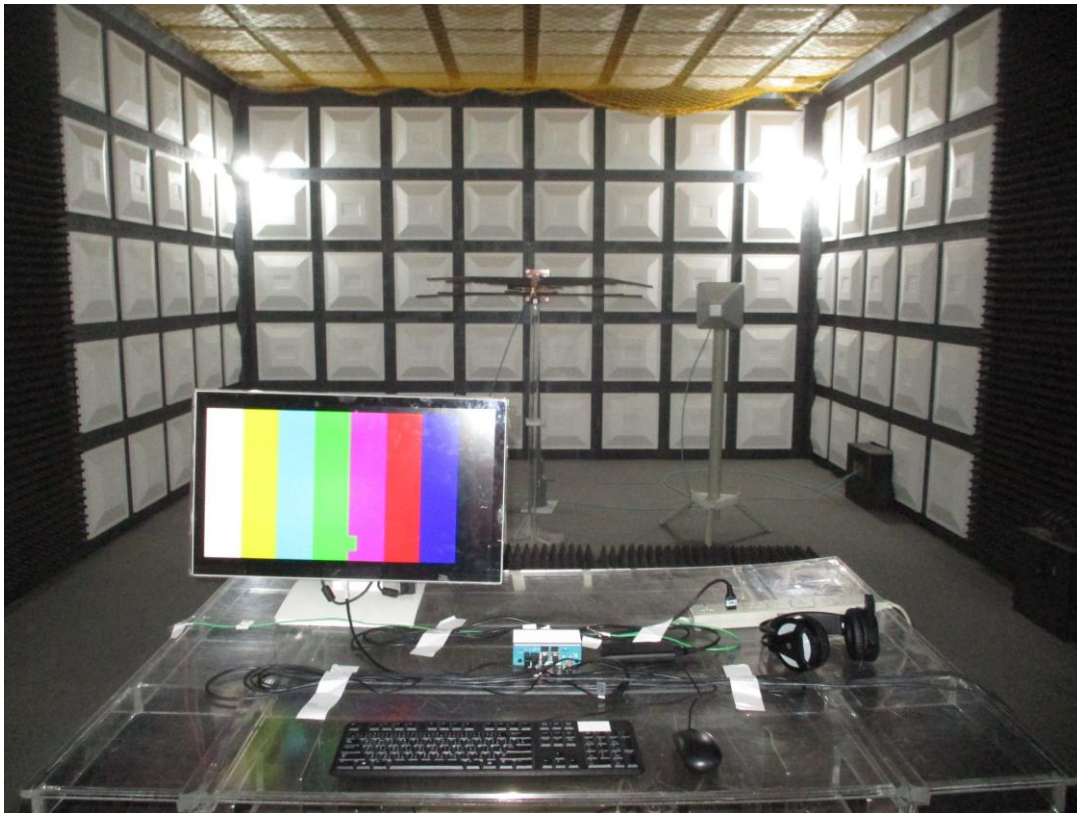
15.4 Harmonics Current, Voltage Fluctuations and Flicker Measurement



15.5 Electrostatic Discharge Immunity Test (ESD)



15.6 Radio-frequency Electromagnetic Field Immunity Test (RS)



15.7 Fast Transients (EFT)

Mains port



LAN



15.8 Surge

Mains ports

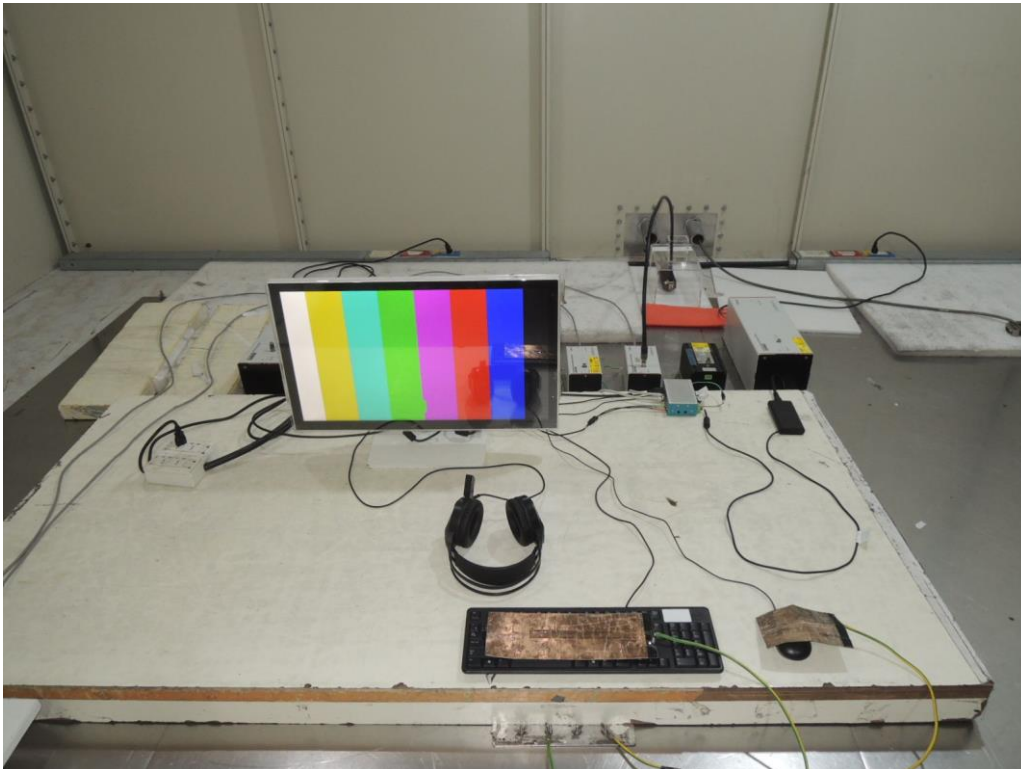


15.9 Radio-frequency common mode (CS)

Mains port



LAN



Appendix – Information of the Testing Laboratories

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved according to ISO/IEC 17025.

If you have any comments, please feel free to contact us at the following:

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Fax: 886-2-26051924

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Email: service.adt@bureauveritas.com

Web Site: <http://ee.bureauveritas.com.tw>

The address and road map of all our labs can be found in our web site also.

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